

## TOTAL IONIZING DOSE TEST REPORT

*No. 05T-RTAX1000S-D1GAH1*

*August 8, 2005*

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### I. SUMMARY TABLE

Parameter	Tolerance
1. Gross Functionality	Passed 300 krad (Si)
2. Power Supply Current ( $I_{CCA}/I_{CCI}$ )	Post 200 krad (Si) and after 30 days room temperature annealing: average delta $I_{CCA} \leq 0$ mA; average delta $I_{CCI} \leq 11.7$ mA. Post 300 krad (Si) and after 10 days room temperature annealing: average delta $I_{CCA} \leq 0$ mA; average delta $I_{CCI} \leq 37.3$ mA.
3. Input Threshold ( $V_{TH}/V_{IH}$ )	Passed 300 krad (Si)
4. Output Drive ( $V_{OL}/V_{OH}$ )	Passed 300 krad (Si)
5. Propagation Delay	Passed 300 krad (Si) for 10% degradation criterion
6. Transition Time	Passed 300 krad (Si)

### II. TOTAL IONIZING DOSE (TID) TESTING

This testing is designed on the base of an extensive database (see, for example, TID data of antifuse-based FPGA in <http://www.klabs.org/> and <http://www.actel.com/>) accumulated from the TID testing of many generations of antifuse-based FPGAs. One distinctive quality about this testing is the bench measurement of electrical parameters. Compared to an automatic-tester measurement, the bench measurement provides lower noise, better accuracy and flexibility. The bench measurement samples pins for the measurements. However, two factors make sampling appropriate: first, the tolerance is often determined by either the  $I_{CC}$  or propagation delay, both are global parameters; second, the total dose effect is uniformly distributed across the chip.

#### A. Device-Under-Test (DUT) and Irradiation Parameters

Table 1 lists the DUT and irradiation parameters. During irradiation each input and most of the output is grounded through a 100k-ohm resistor; during annealing each input or output is tied to the ground or  $V_{CCI}$  with a 2.7-k ohm resistor. Appendix A contains the schematics of the irradiation-bias circuit.

Table 1 DUT and Irradiation Parameters

Part Number	RTAX1000S
Package	CQFP352
Foundry	United Microelectronics Corp.
Technology	0.15 $\mu$ m CMOS
DUT Design	RTAX1000S_TID
Die Lot Number	D1GAH1
Quantity Tested	6
Serial Number	300 krad: 61540, 61544, 61545 200 krad: 61546, 61547, 61561
Radiation Facility	Defense Microelectronics Activity
Radiation Source	Co-60
Dose Rate ( $\pm 5\%$ )	3 krad (Si)/min: 61540, 61544, 61545 2 krad (Si)/min: 61546, 61547, 61561
Irradiation Temperature	Room
Irradiation and Measurement Bias ( $V_{CCI}/V_{CCA}$ )	Static at 3.3 V/1.5 V
IO Configuration	Single ended: LVTTL Differential pair: LVPECL

## B. Test Method

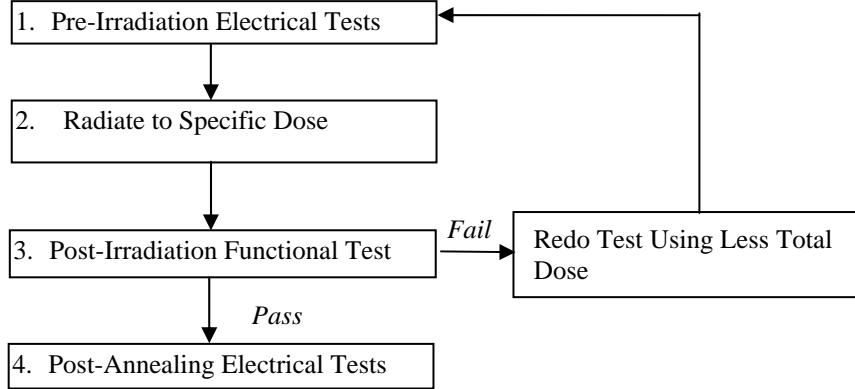


Figure 1 Parametric test flow chart

The test method generally follows the guidelines in the military standard TM1019. Figure 1 is the flow chart showing the steps for parametric tests, irradiation, and post-irradiation annealing.

The accelerated aging, or rebound test mentioned in TM1019 is unnecessary because there is no adverse time dependent effect (TDE) in products manufactured by sub-micron CMOS technology. Elevated temperature annealing reduces the effects originated from radiation-induced leakages. As indicated by testing data in the following sections, the predominant radiation effects in RTAX1000S are due to radiation-induced leakages.

Room temperature annealing is performed in this test; the duration is approximately 30 days.

## C. Design and Parametric Measurements

DUTs use a high utilization generic design (RTAX1000S\_TID) to test total dose effects in typical space applications. Appendix B contains the schematics and Verilog files for the logic design.

Table 2 lists each electrical parameter to be measured and the corresponding logic design. The functionality is measured on the output pin (O\_BS) of a combinational buffer-string with 10,000 buffers, output pins (O\_ANDP\_CLKF, O\_ORP\_CLKF, O\_FF\_CLKF, O\_ANDC\_CLKF, O\_ORC\_CLKF, O\_ANDP\_CLKG, O\_ORP\_CLKG, O\_FF\_CLKG, O\_ANDC\_CLKG, O\_ORC\_CLKG, O\_ANDP\_CLKH, O\_ORP\_CLKH, O\_FF\_CLKH, O\_ANDC\_CLKH, O\_ORC\_CLKH, O\_ANDP\_HCLKA, O\_ORP\_HCLKA, O\_FF\_HCLKA, O\_ANDC\_HCLKA, and O\_ORC\_HCLKA) of four (4) shift registers with 5,632 bits total, and eight of the output pins (OUTX0, OUTX1, OUTX2, OUTX3, OUTX4, OUTX5, OUTX6 and OUTX7) of the embedded RAM configured as 2048×9.

$I_{CC}$  is measured on the power supply of the logic-array ( $I_{CCA}$ ) and I/O ( $I_{CCI}$ ) respectively. The input logic threshold ( $V_{IL}/V_{IH}$ ) is measured on single-ended inputs EN8, DA, IO\_I1, IO\_I2, IO\_I3, IO\_I4, IO\_I5 and IO\_I6, and also on differential inputs DIO\_I1P, DIO\_I2P, DIO\_I3P, DIO\_I4P, DIO\_I5P, DIO\_I6P and DIO\_I7P. The differential inputs are configured as LVPECL instead of LVDS. Because LVPECL uses 3.3 VDC, which is higher than 2.5 VDC used by LVDS, it is the worst case among the differential pairs. During the measurement on the differential inputs, the N (negative) side of the differential pair is biased at 1.8 V. The output-drive voltage ( $V_{OL}/V_{OH}$ ) is measured on QA0. The propagation delay is measured on the output (O\_BS) of the buffer string. The definition is the time delay from the triggering edge at the CLOCK input to the switching edge at the output O\_BS. Both the delays of low-to-high and high-to-low output transitions are measured; the reported delay is the average of these two measurements. The transition characteristics, measured on the output O\_BS, are shown as oscilloscope snapshots.

Table 2 Logic Design for Parametric Measurements

Parameters	Logic Design
1. Functionality	All key logic functions (O_BS, O_ANDP_CLKF, O_ORP_CLKF, O_FF_CLKF, O_ANDC_CLKF, O_ORC_CLKF, O_ANDP_CLKG, O_ORP_CLKG, O_FF_CLKG, O_ANDC_CLKG, O_ORC_CLKG, O_ANDP_CLKH, O_ORP_CLKH, O_FF_CLKH, O_ANDC_CLKH, O_ORC_CLKH, O_ANDP_HCLKA, O_ORP_HCLKA, O_FF_HCLKA, O_ANDC_HCLKA, and O_ORC_HCLKA), and outputs of embedded RAM (OUTX0, OUTX1, OUTX2, OUTX3, OUTX4, OUTX5, OUTX6 and OUTX7)
2. $I_{CC}$ ( $I_{CCA}/I_{CCI}$ )	DUT power supply
3. Input Threshold ( $V_{IL}/V_{IH}$ )	Single ended inputs (EN8/YQ0, DA/QA0, IO_I1/IO_O1, IO_I2/IO_O2, IO_I3/IO_O3, IO_I4/IO_O4, IO_I5/IO_O5, IO_I6/IO_O6), and differential inputs (DIO_I1P/DIO_O1, DIO_I2P/DIO_O2, DIO_I3P/DIO_O3, DIO_I4P/DIO_O4, DIO_I5P/DIO_O5, DIO_I6P/DIO_O6, DIO_I7P/DIO_O7)
4. Output Drive ( $V_{OL}/V_{OH}$ )	Output buffer (DA/QA0)
5. Propagation Delay	String of buffers (CLOCK to O_BS)
6. Transition Characteristic	D flip-flop output (O_BS)

### III. TEST RESULTS

#### A. Functionality

Every DUT passed the pre-irradiation and post-annealing functional tests. The as-irradiated DUT is functionally tested on the output (O\_FF\_HCLKA) of the largest shift register.

#### B. Power Supply Current ( $I_{CCA}$ and $I_{CCI}$ )

Figures 2 to 7 show the in-flux power supply current ( $I_{CC}$ ). Table 3 summarizes the pre-irradiation, post-irradiation and post-annealing  $I_{CC}$ . The post-annealing  $I_{CC}$  for four different bit patterns, all '0', all '1', checkerboard and inverted-checkerboard, in the RAM are basically the same value.

Table 3 Pre-irradiation, Post Irradiation and Post-Annealing  $I_{CC}$

DUT	Total Dose (krad)	$I_{CCA}$ (mA)			$I_{CCI}$ (mA)		
		Pre-irrad	Post-irrad	Post-ann	Pre-irrad	Post-irrad	Post-ann
61540	300	5	25	3	18	112	40
61544	300	8	60	8	18	133	71
61545	300	11	75	11	19	171	56
61546	200	9	17	7	18	68	31
61547	200	14	29	6	19	131	29
61561	200	14	25	10	18	67	30

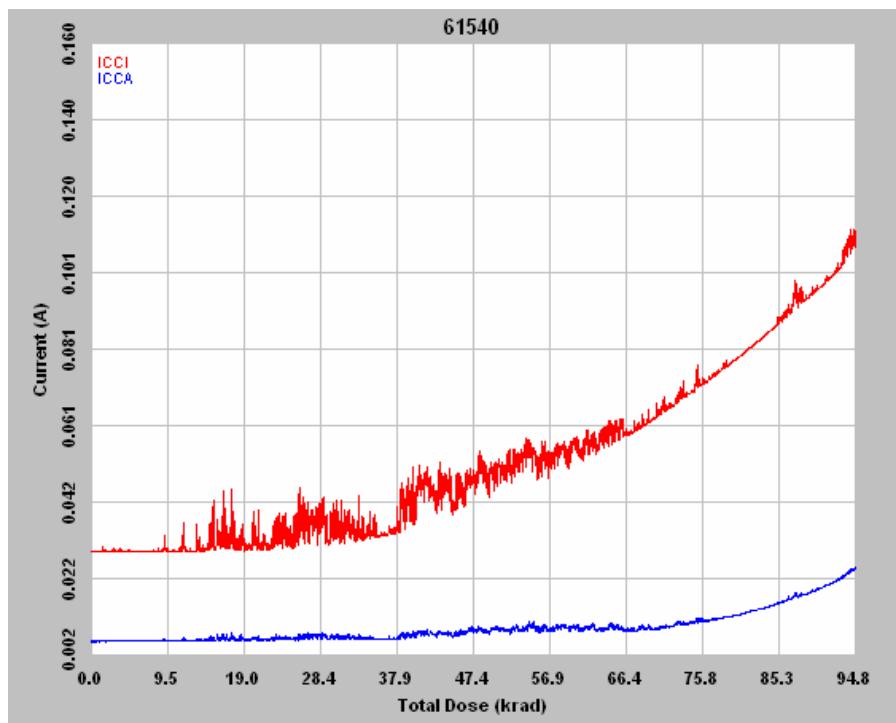


Figure 2 DUT 61540 in-flux  $I_{CCA}$  and  $I_{CCI}$

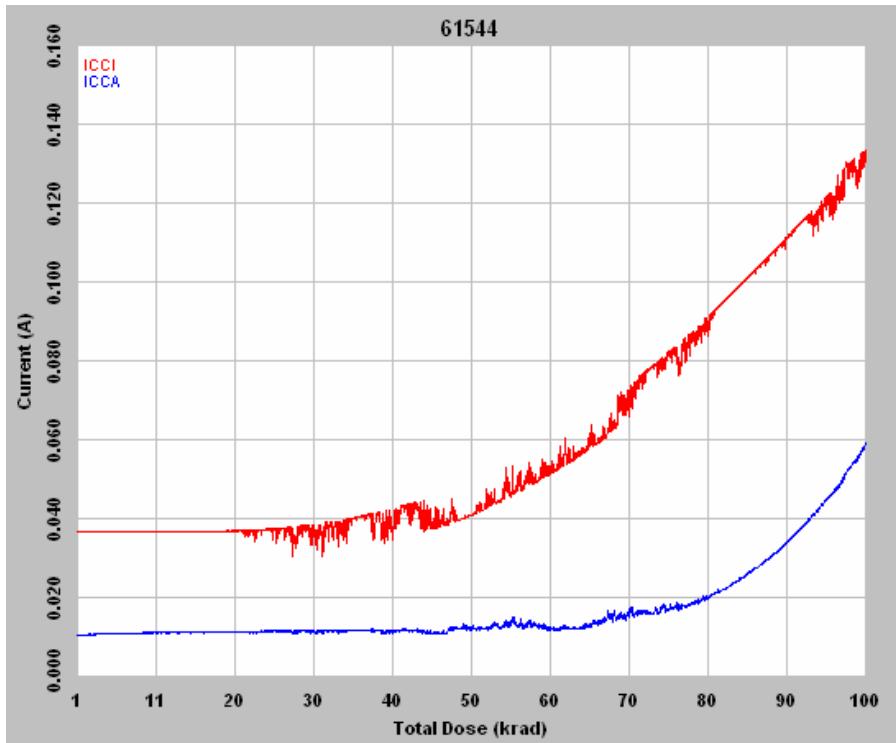


Figure 3 DUT 61544 in-flux  $I_{CCA}$  and  $I_{CCI}$

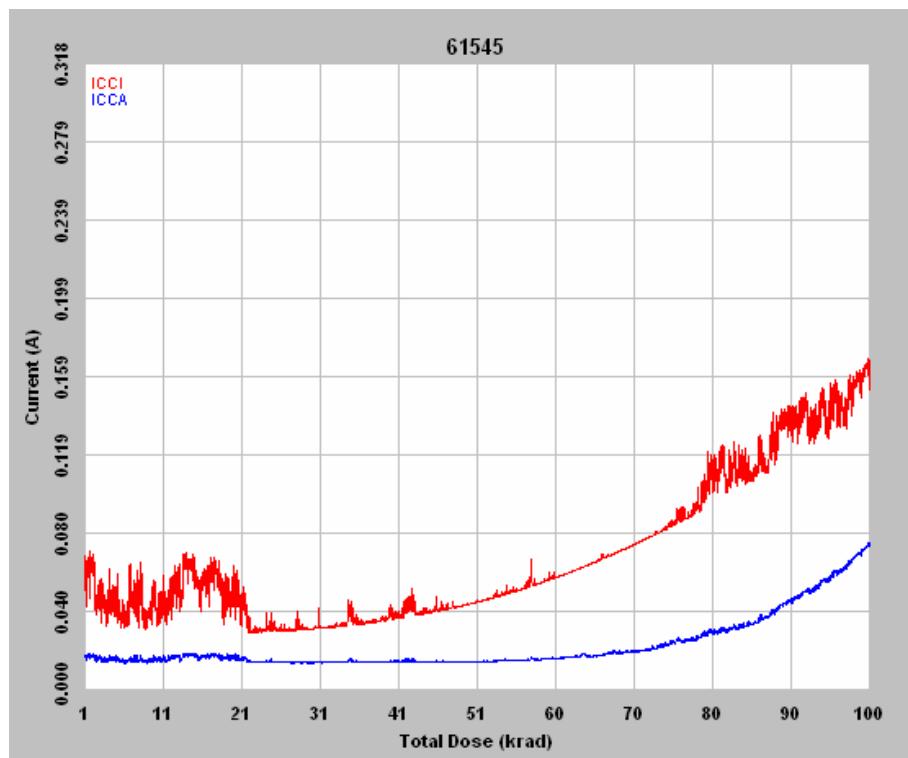


Figure 4 DUT 61545 in-flux  $I_{CCA}$  and  $I_{CCI}$

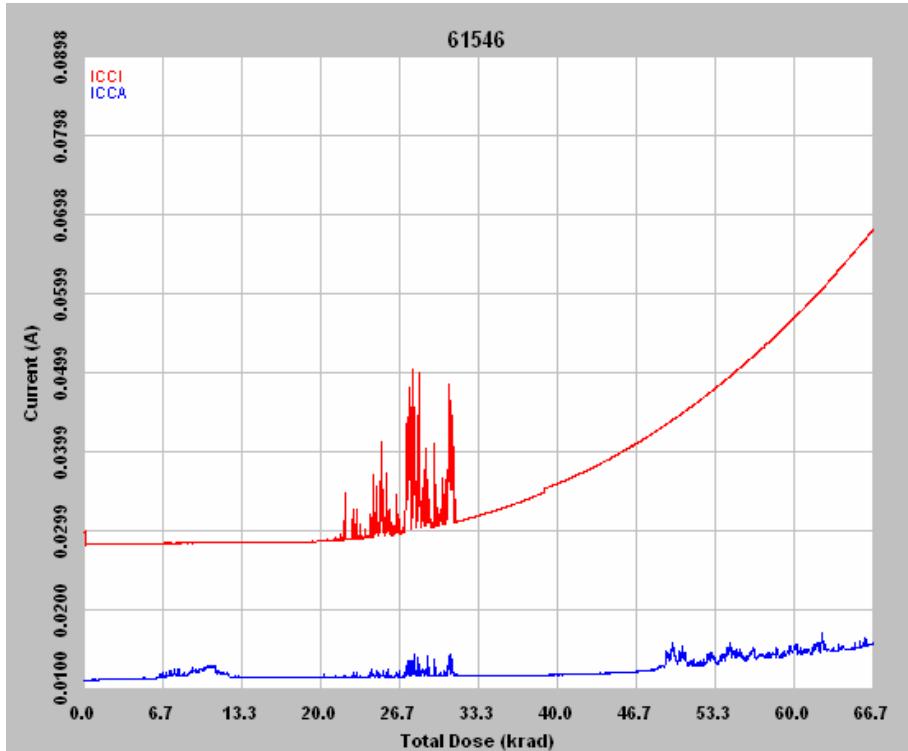


Figure 5 DUT 61546 in-flux  $I_{CCA}$  and  $I_{CCI}$

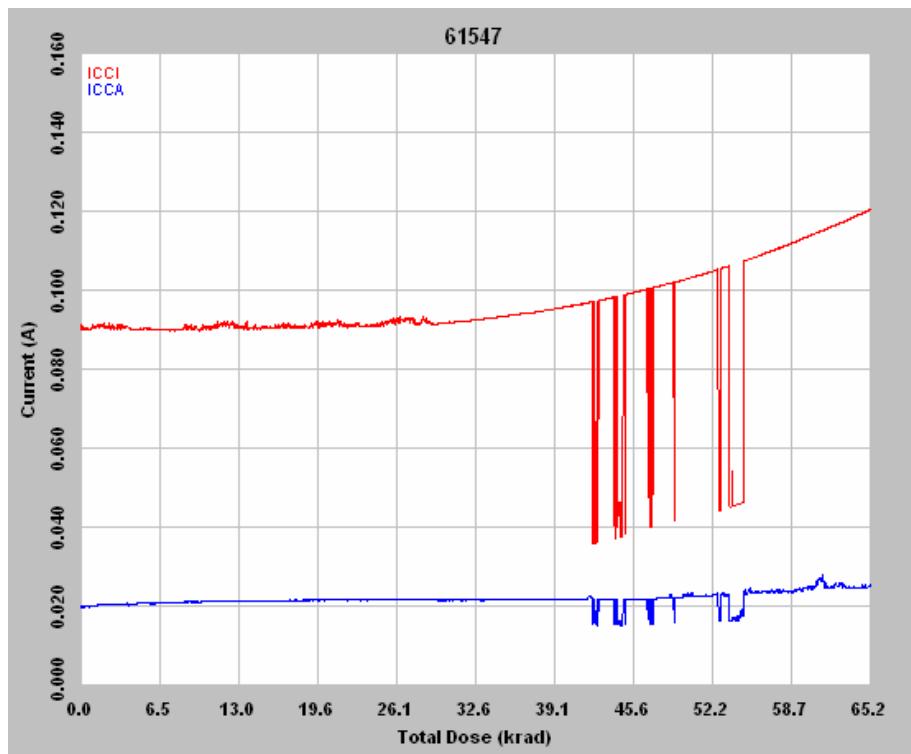


Figure 6 DUT 61547 in-flux  $I_{CCA}$  and  $I_{CCI}$

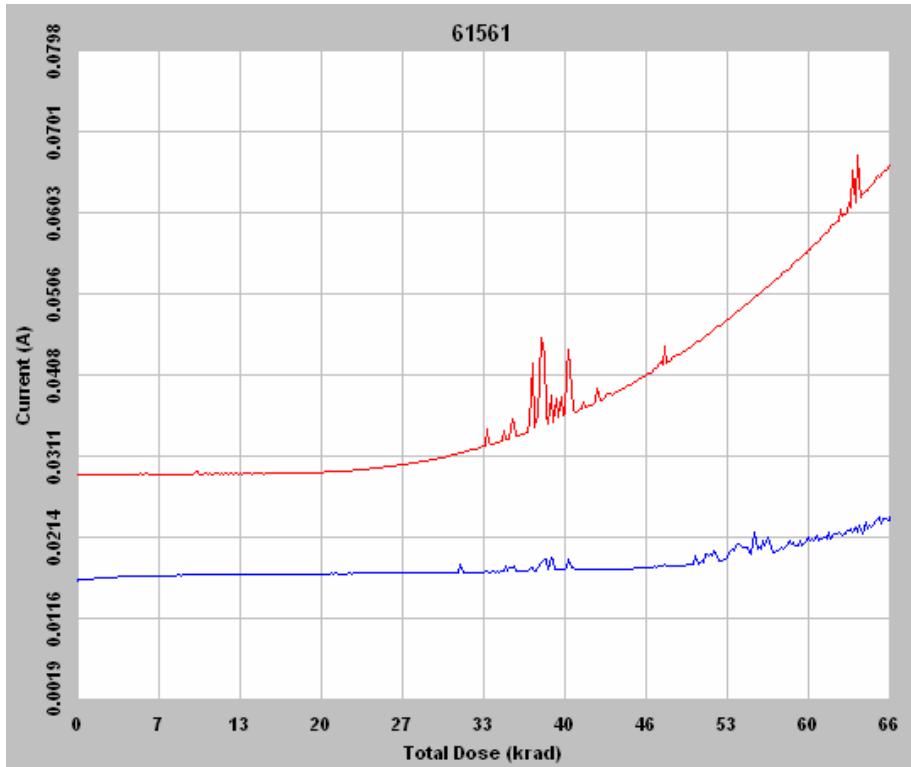


Figure 7 DUT 61561 in-flux  $I_{CCA}$  and  $I_{CCI}$

### C. Single-Ended Input Logic Threshold ( $V_{IL}/V_{IH}$ )

Table 4 lists the pre-irradiation and post-annealing single-ended input logic threshold. All data are within the spec limits, and the post-annealing shift in every case is less than 10%.

Table 4a Pre-Irradiation and Post-Annealing Input Thresholds

In/Out Pin:		IO_I1/IO_O1				IO_I2/IO_O2			
DUT	Total Dose	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann
		$V_{IL}$ (V)		$V_{IH}$ (V)		$V_{IL}$ (V)		$V_{IH}$ (V)	
61540	300 krad	1.45	1.48	1.57	1.53	1.48	1.49	1.55	1.52
61544	300 krad	1.46	1.48	1.56	1.55	1.46	1.48	1.56	1.55
61545	300 krad	1.45	1.49	1.57	1.54	1.48	1.49	1.56	1.54
61546	200 krad	1.46	1.49	1.58	1.53	1.47	1.49	1.57	1.53
61547	200 krad	1.47	1.49	1.58	1.54	1.47	1.48	1.56	1.54
61561	200 krad	1.46	1.49	1.57	1.52	1.47	1.49	1.56	1.52

Table 4b Pre-Irradiation and Post-Annealing Input Thresholds

In/Out Pin:		IO_I3/IO_O3				IO_I4/IO_O4			
DUT	Total Dose	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann
		$V_{IL}$ (V)		$V_{IH}$ (V)		$V_{IL}$ (V)		$V_{IH}$ (V)	
61540	300 krad	1.46	1.49	1.56	1.52	1.46	1.49	1.57	1.52
61544	300 krad	1.46	1.48	1.56	1.55	1.47	1.48	1.56	1.55
61545	300 krad	1.46	1.49	1.57	1.54	1.47	1.49	1.57	1.54
61546	200 krad	1.47	1.48	1.58	1.53	1.47	1.48	1.58	1.53
61547	200 krad	1.46	1.48	1.58	1.54	1.46	1.48	1.58	1.53
61561	200 krad	1.46	1.49	1.57	1.53	1.46	1.49	1.57	1.52

Table 4c Pre-Irradiation and Post-Annealing Input Thresholds

In/Out Pin:		IO_I5/IO_O5				IO_I6/IO_O6			
DUT	Total Dose	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann
		$V_{IL}$ (V)		$V_{IH}$ (V)		$V_{IL}$ (V)		$V_{IH}$ (V)	
61540	300 krad	1.47	1.49	1.57	1.52	1.47	1.48	1.55	1.52
61544	300 krad	1.47	1.49	1.56	1.54	1.47	1.49	1.56	1.54
61545	300 krad	1.46	1.49	1.57	1.54	1.48	1.49	1.56	1.54
61546	200 krad	1.46	1.49	1.58	1.53	1.47	1.49	1.57	1.53
61547	200 krad	1.46	1.49	1.57	1.54	1.47	1.48	1.57	1.54
61561	200 krad	1.46	1.49	1.57	1.52	1.47	1.49	1.56	1.52

Table 4d Pre-Irradiation and Post-Annealing Input Thresholds

In/Out Pin:		DA/QA0				EN8/YQ0			
DUT	Total Dose	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann
		$V_{IL}$ (V)		$V_{IH}$ (V)		$V_{IL}$ (V)		$V_{IH}$ (V)	
61540	300 krad	1.47	1.49	1.57	1.52	1.48	1.48	1.54	1.53
61544	300 krad	1.47	1.49	1.56	1.54	1.48	1.48	1.54	1.54
61545	300 krad	1.47	1.49	1.56	1.54	1.48	1.49	1.54	1.54
61546	200 krad	1.47	1.49	1.57	1.53	1.48	1.49	1.56	1.53
61547	200 krad	1.47	1.48	1.55	1.53	1.48	1.49	1.55	1.53
61561	200 krad	1.48	1.48	1.56	1.55	1.49	1.48	1.54	1.54

#### D. Differential Input (LVPECL) Threshold Voltage ( $V_{IL}/V_{IH}$ )

Table 5 shows the LVPECL differential input threshold voltage changes due to irradiations. Except pin DIO\_I16P in DUT 61546 shows 11% change in  $V_{IH}$  after irradiation and annealing, in every other case the threshold change is below 10%. Also every data is well within the product specification.

Table 5a Pre-Irradiation and Post-Annealing Differential Input Thresholds

In/Out Pin:		DIO_I1P/DIO_O1				DIO_I2P/DIO_O2			
DUT	Total Dose	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann
		$V_{IL}$ (V)		$V_{IH}$ (V)		$V_{IL}$ (V)		$V_{IH}$ (V)	
61540	300 krad	1.76	1.74	1.79	1.81	1.76	1.74	1.78	1.81
61544	300 krad	1.75	1.73	1.78	1.81	1.75	1.73	1.78	1.81
61545	300 krad	1.76	1.75	1.79	1.81	1.76	1.75	1.79	1.81
61546	200 krad	1.76	1.74	1.79	1.82	1.74	1.75	1.79	1.82
61547	200 krad	1.76	1.75	1.79	1.82	1.76	1.74	1.79	1.82
61561	200 krad	1.76	1.75	1.79	1.82	1.75	1.73	1.79	1.81

Table 5b Pre-Irradiation and Post-Annealing Differential Input Thresholds

In/Out Pin:		DIO_I3P/DIO_O3				DIO_I4P/DIO_O4			
DUT	Total Dose	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann
		$V_{IL}$ (V)		$V_{IH}$ (V)		$V_{IL}$ (V)		$V_{IH}$ (V)	
61540	300 krad	1.76	1.74	1.79	1.81	1.76	1.73	1.79	1.81
61544	300 krad	1.76	1.73	1.78	1.82	1.75	1.73	1.78	1.81
61545	300 krad	1.75	1.74	1.79	1.82	1.76	1.74	1.78	1.81
61546	200 krad	1.76	1.74	1.79	1.82	1.75	1.74	1.78	1.82
61547	200 krad	1.76	1.74	1.79	1.82	1.76	1.74	1.78	1.82
61561	200 krad	1.75	1.74	1.79	1.82	1.75	1.74	1.79	1.82

Table 5c Pre-Irradiation and Post-Annealing Differential Input Thresholds

In/Out Pin:		DIO_I5P/DIO_O5				DIO_I6P/DIO_O6			
DUT	Total Dose	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann
		$V_{IL}$ (V)		$V_{IH}$ (V)		$V_{IL}$ (V)		$V_{IH}$ (V)	
61540	300 krad	1.76	1.73	1.79	1.81	1.75	1.73	1.78	1.80
61544	300 krad	1.75	1.73	1.78	1.81	1.76	1.70	1.78	1.83
61545	300 krad	1.76	1.74	1.79	1.82	1.76	1.74	1.79	1.82
61546	200 krad	1.76	1.74	1.79	1.82	1.75	1.86	1.78	2.00
61547	200 krad	1.76	1.74	1.79	1.82	1.75	1.73	1.78	1.81
61561	200 krad	1.76	1.75	1.79	1.82	1.76	1.74	1.79	1.82

Table 5d Pre-Irradiation and Post-Annealing Differential Input Thresholds

In/Out Pin:		DIO_I7P/DIO_O7			
DUT	Total Dose	Pre-Irrad	Post-Ann	Pre-Irrad	Post-Ann
		$V_{IL}$ (V)		$V_{IH}$ (V)	
61540	300 krad	1.77	1.74	1.80	1.82
61544	300 krad	1.76	1.73	1.78	1.81
61545	300 krad	1.76	1.74	1.79	1.82
61546	200 krad	1.77	1.75	1.79	1.82
61547	200 krad	1.76	1.75	1.79	1.83
61561	200 krad	1.77	1.75	1.80	1.83

### E. Output-Drive Voltage ( $V_{OL}/V_{OH}$ )

The pre-irradiation and post-annealing  $V_{OL}/V_{OH}$  are listed in Tables 6 and 7. The post-annealing data are within the spec limits; in each case, the radiation-induced degradation is well within 10%.

Table 6 Pre-Irradiation and Post-Annealing  $V_{OL}$  (V) at Various Sinking Current

DUT	Total Dose	1 mA		12 mA		20 mA		50 mA		100 mA	
		Pre-rad	Pos-an								
61540	300 krad	0.008	0.008	0.093	0.091	0.156	0.152	0.396	0.385	0.827	0.803
61544	300 krad	0.008	0.008	0.095	0.092	0.159	0.155	0.402	0.392	0.841	0.818
61545	300 krad	0.008	0.008	0.094	0.092	0.157	0.154	0.399	0.389	0.834	0.812
61546	200 krad	0.008	0.008	0.095	0.093	0.159	0.155	0.402	0.392	0.840	0.817
61547	200 krad	0.008	0.008	0.096	0.094	0.161	0.156	0.407	0.396	0.851	0.824
61561	200 krad	0.008	0.008	0.091	0.089	0.152	0.149	0.386	0.377	0.808	0.786

Table 7 Pre-Irradiation and Post-Annealing  $V_{OH}$  (V) at Various Sourcing Current

DUT	Total Dose	1 mA		8 mA		20 mA		50 mA		100 mA	
		Pre-rad	Pos-an								
61540	300 krad	3.29	3.29	3.22	3.21	3.10	3.07	2.78	2.70	2.15	1.96
61544	300 krad	3.29	3.29	3.22	3.21	3.09	3.07	2.77	2.71	2.13	1.98
61545	300 krad	3.29	3.29	3.22	3.21	3.09	3.07	2.77	2.72	2.13	2.01
61546	200 krad	3.29	3.29	3.22	3.21	3.10	3.08	2.77	2.74	2.14	2.07
61547	200 krad	3.29	3.29	3.22	3.21	3.09	3.08	2.77	2.74	2.14	2.06
61561	200 krad	3.29	3.29	3.22	3.22	3.10	3.09	2.79	2.74	2.17	2.08

### F. Propagation Delay

Table 8 lists the post-annealing propagation delays. In every case, the degradation is well within the 10% criterion. The negative degradations are probably due to measurement noise.

Table 8 Radiation-Induced Propagation Delay Degradations

DUT	Total Dose	Pre-Irradiation	Post-Annealing	Degradation
61540	300 krad	4.222	4.21	-0.23%
61544	300 krad	4.068	4.09	0.45%
61545	300 krad	3.968	3.96	-0.28%
61546	200 krad	3.875	3.92	1.15%
61547	200 krad	3.766	3.81	1.06%
61561	200 krad	3.902	3.95	1.13%

#### G. Transition Time

Figures 8 to 19 show the pre-irradiation and post-annealing transition edges. In each case, the radiation-induced transition-time degradation is not observable.

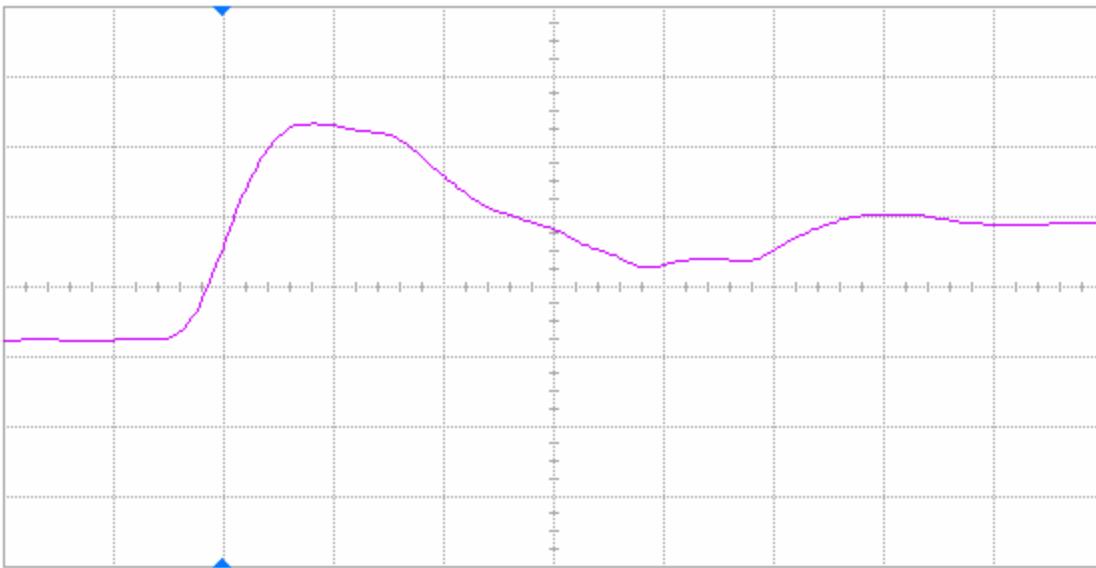


Figure 8(a) DUT 61540 pre-irradiation rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

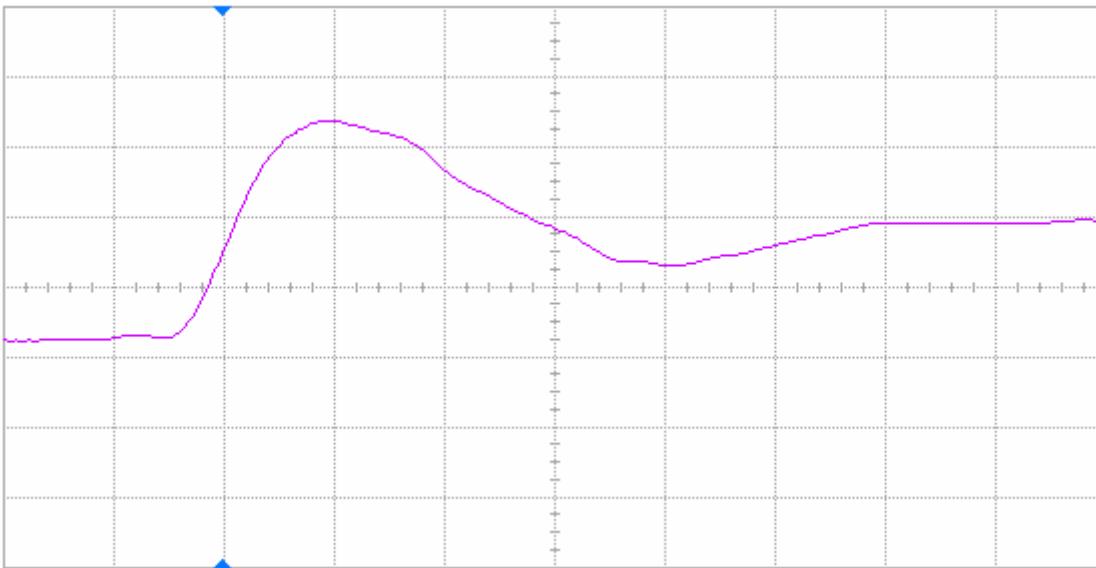


Figure 8(b) DUT 61540 post-annealing rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

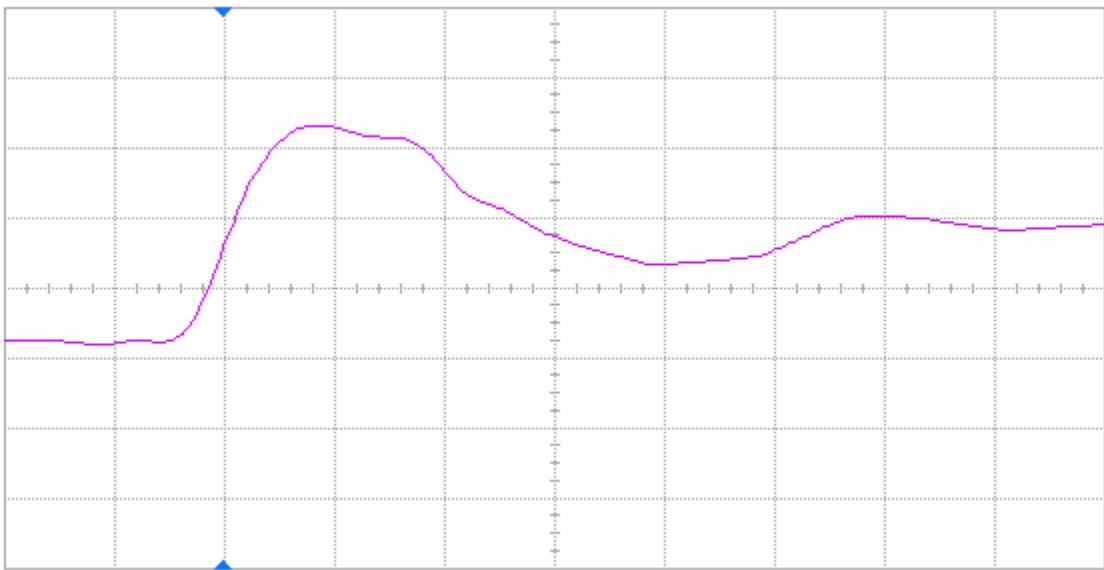


Figure 9(a) DUT 61544 pre-irradiation rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

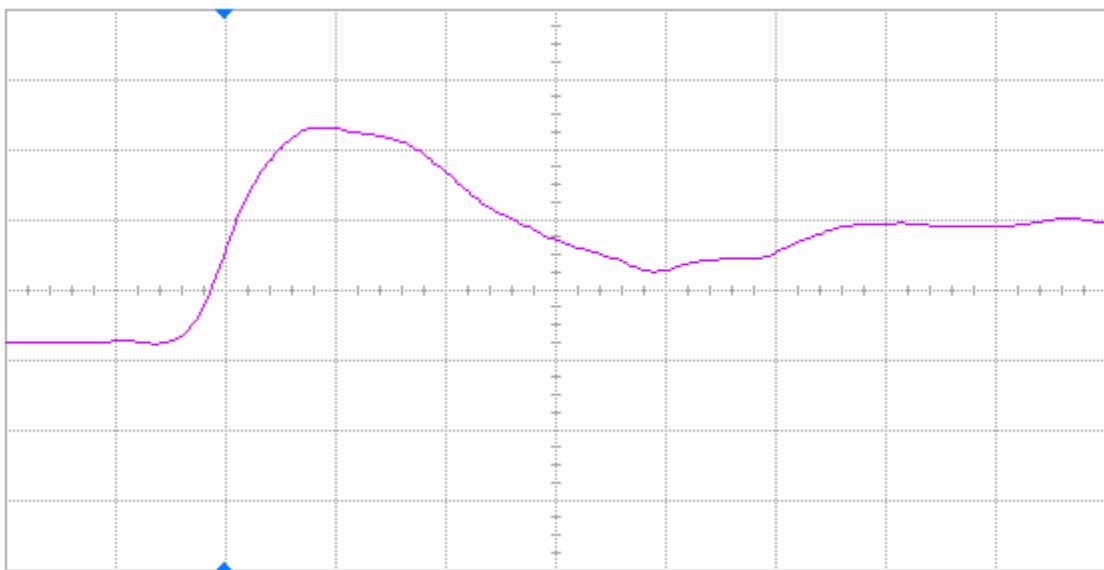


Figure 9(b) DUT 61544 post-annealing rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

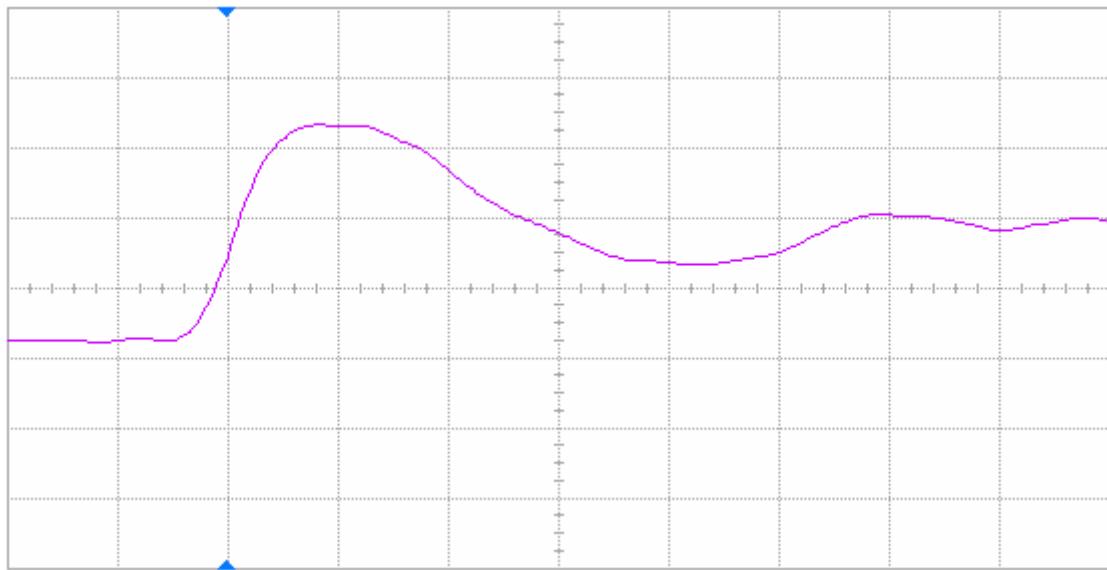


Figure 10(a) DUT 61545 pre-radiation rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

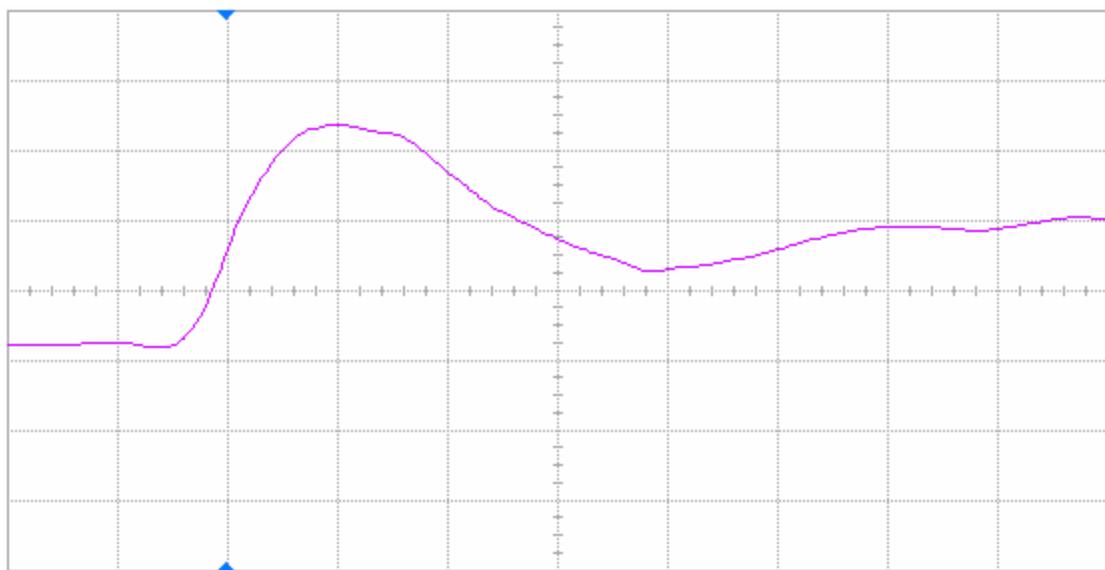


Figure 10(b) DUT 61545 post-annealing rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

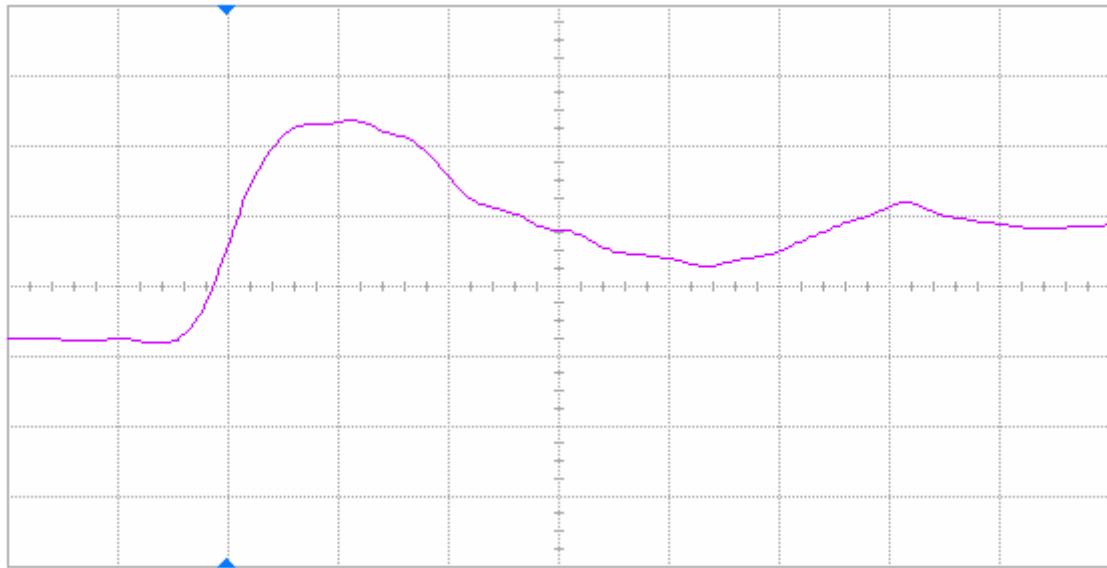


Figure 11(a) DUT 61546 pre-irradiation rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

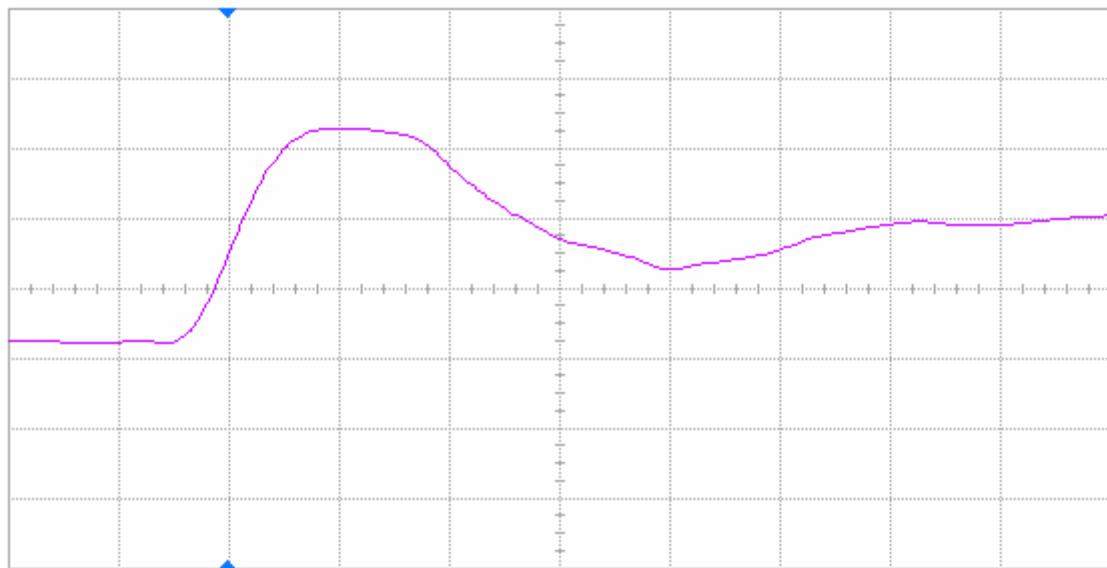


Figure 11(b) DUT 61546 post-annealing rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

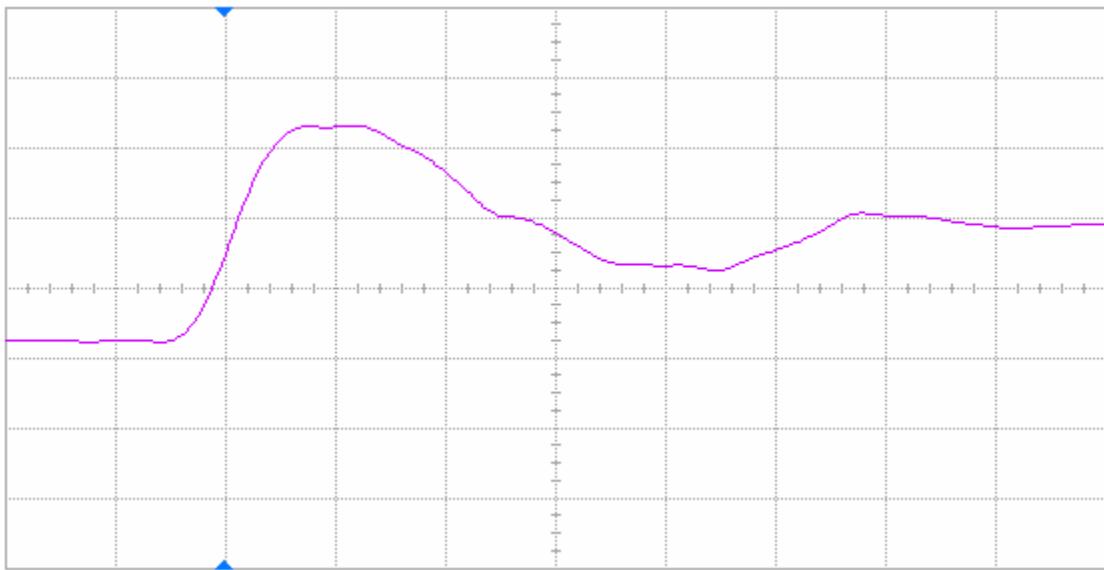


Figure 12(a) DUT 61547 pre-irradiation rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

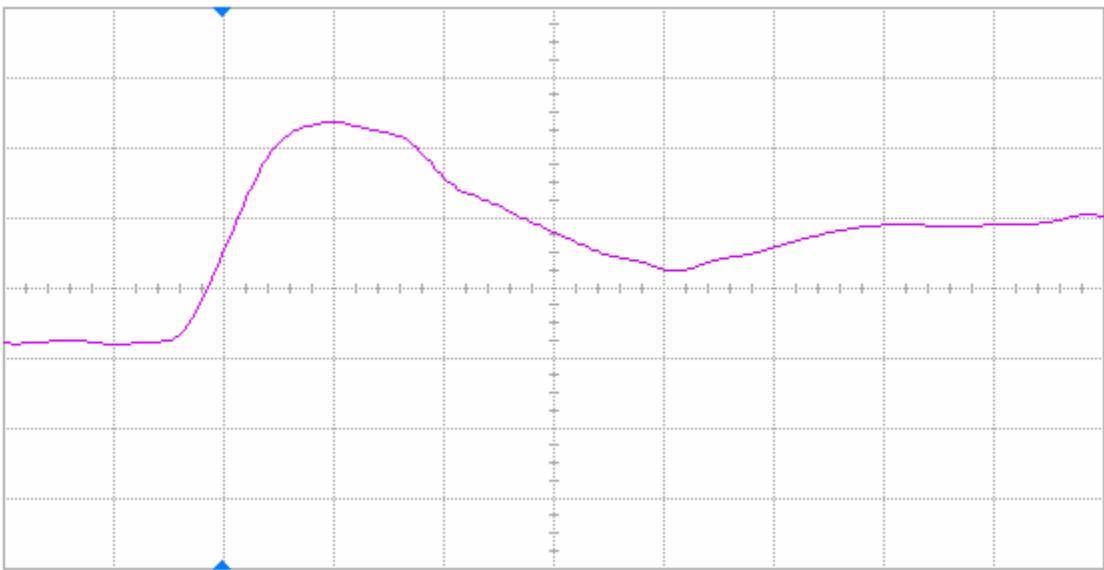


Figure 12(b) DUT 61547 post-annealing rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

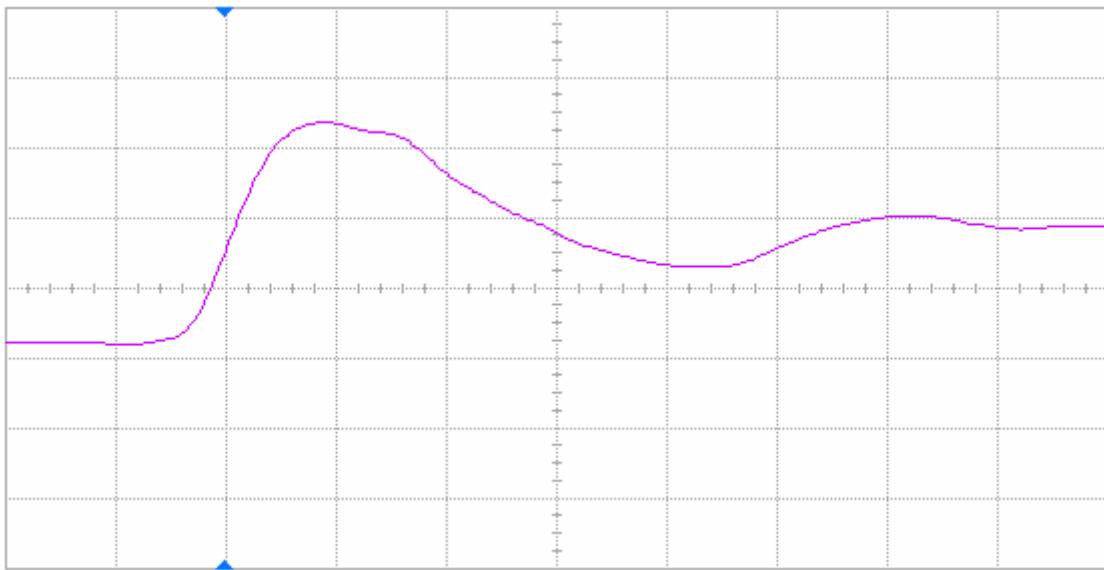


Figure 13(a) DUT 61561 pre-irradiation rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

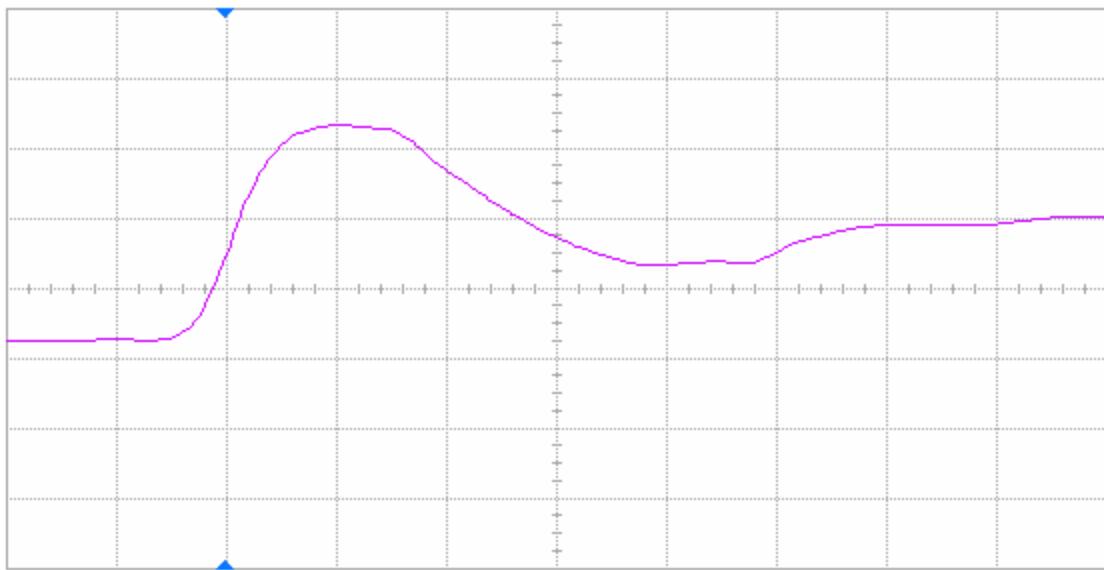


Figure 13(b) DUT 61561 post-annealing rising edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

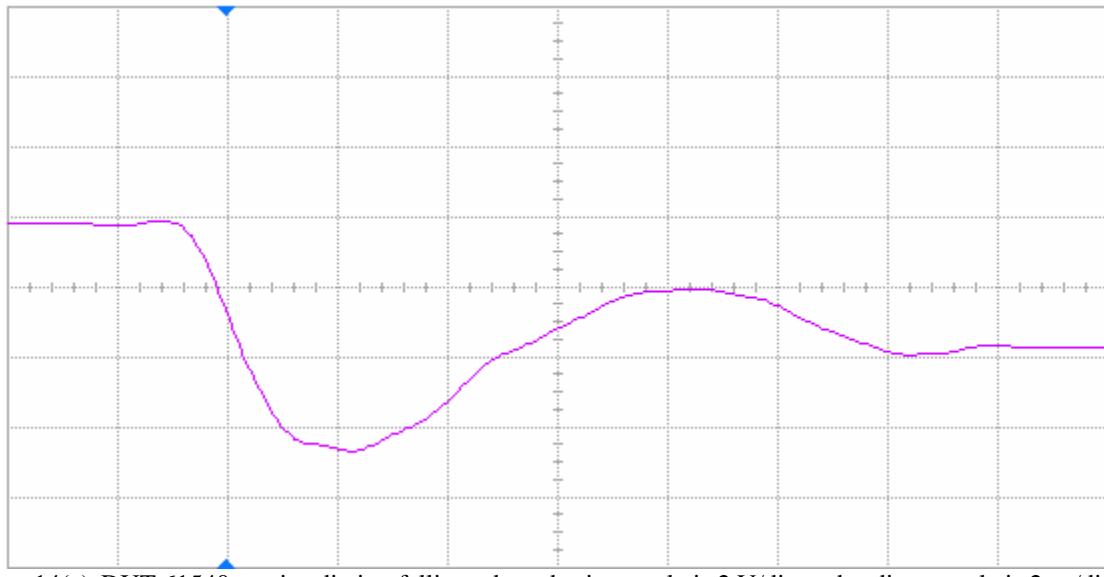


Figure 14(a) DUT 61540 pre-irradiation falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

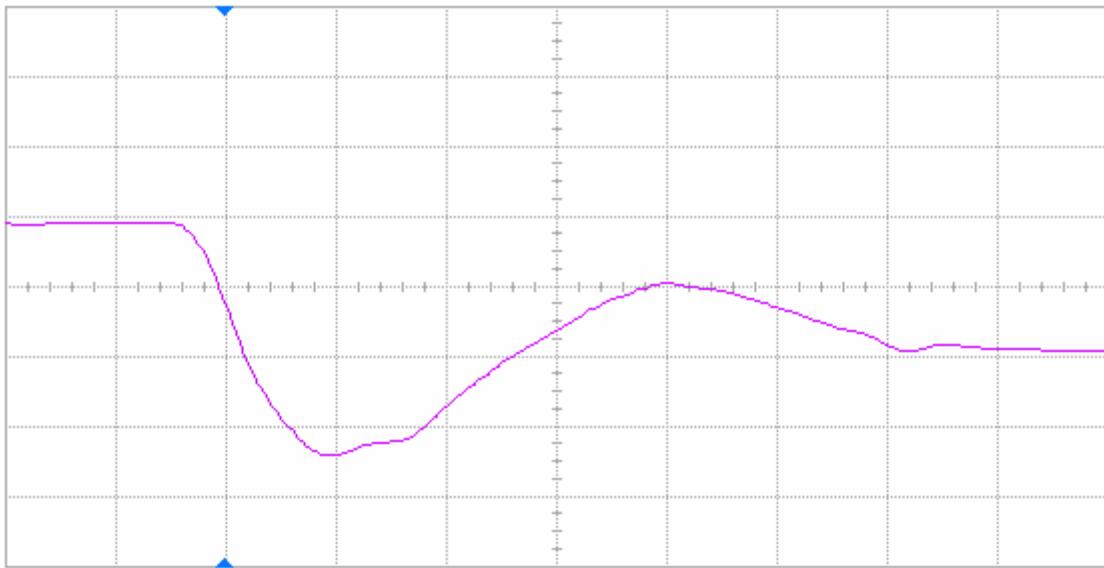


Figure 14(b) DUT 61540 post-annealing falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

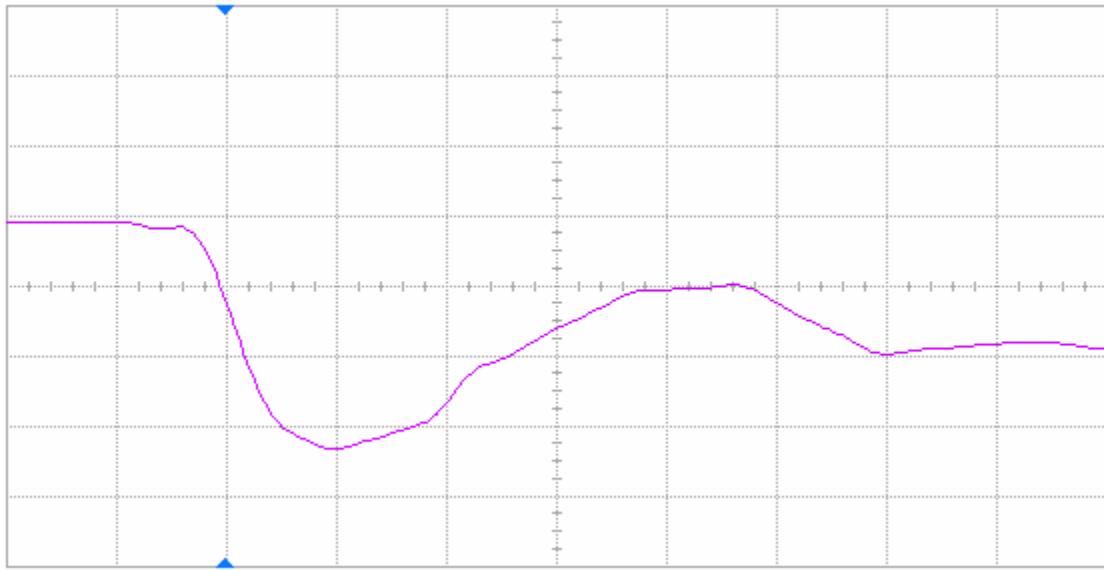


Figure 15(a) DUT 61544 pre-irradiation falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

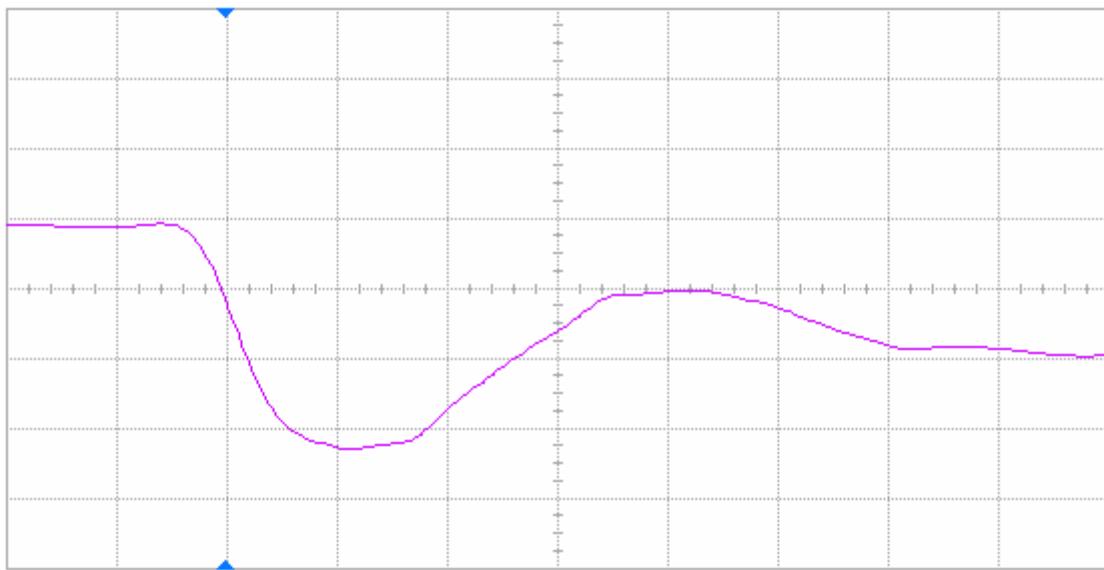


Figure 15(b) DUT 61544 post-annealing falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

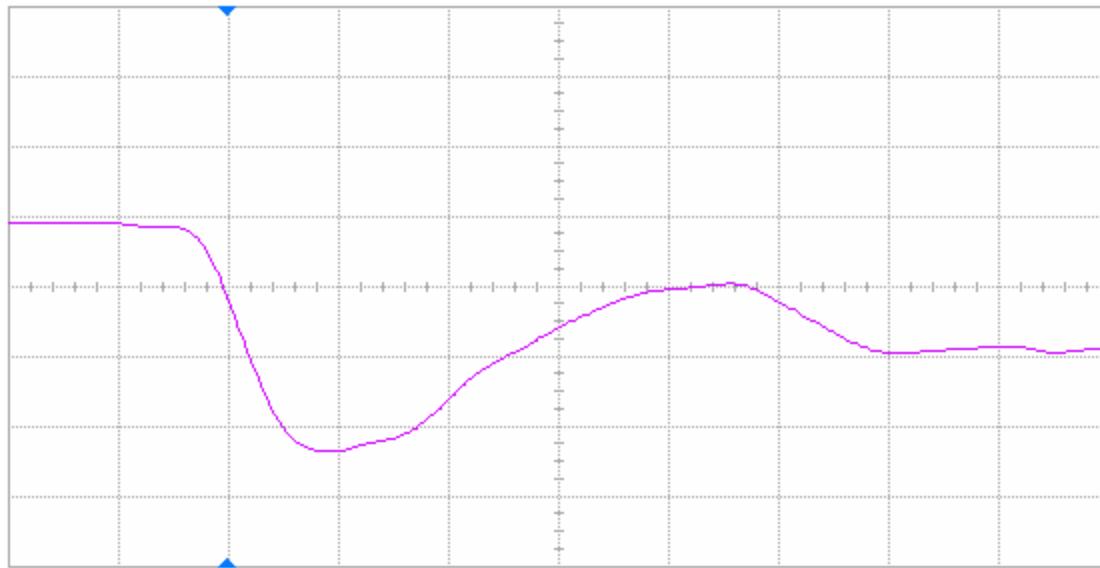


Figure 16(a) DUT 61545 pre-irradiation falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

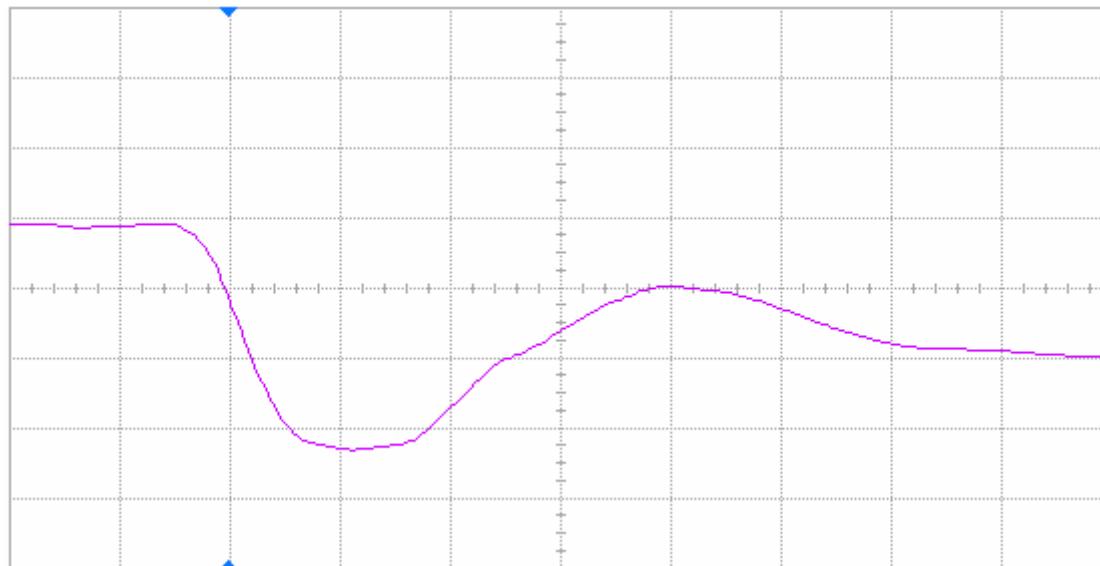


Figure 16(b) DUT 61545 post-annealing falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

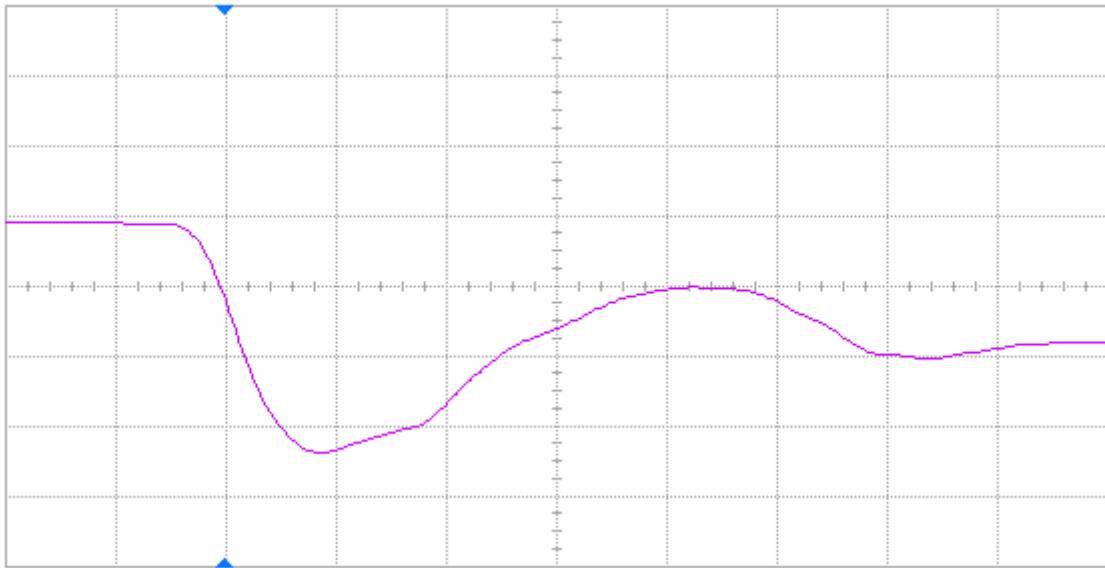


Figure 17(a) DUT 61546 pre-irradiation falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

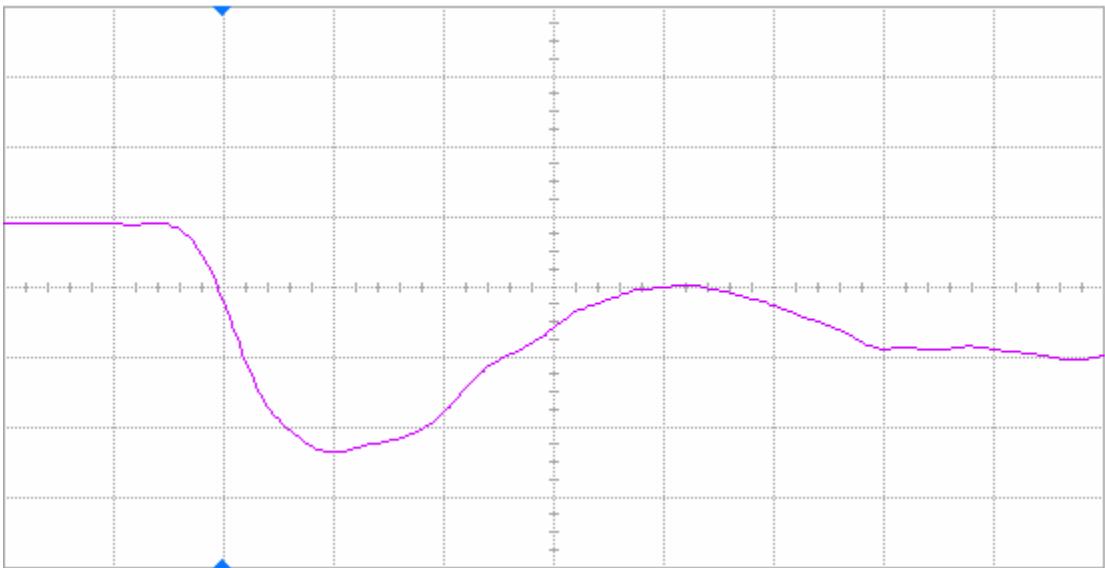


Figure 17(b) DUT 61546 post-annealing falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

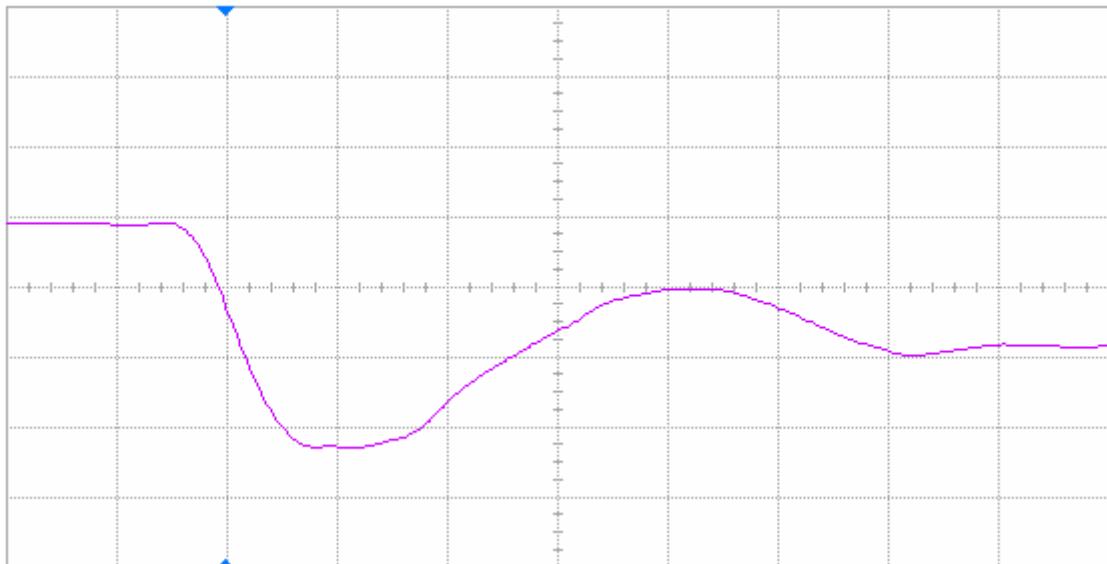


Figure 18(a) DUT 61547 pre-irradiation falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

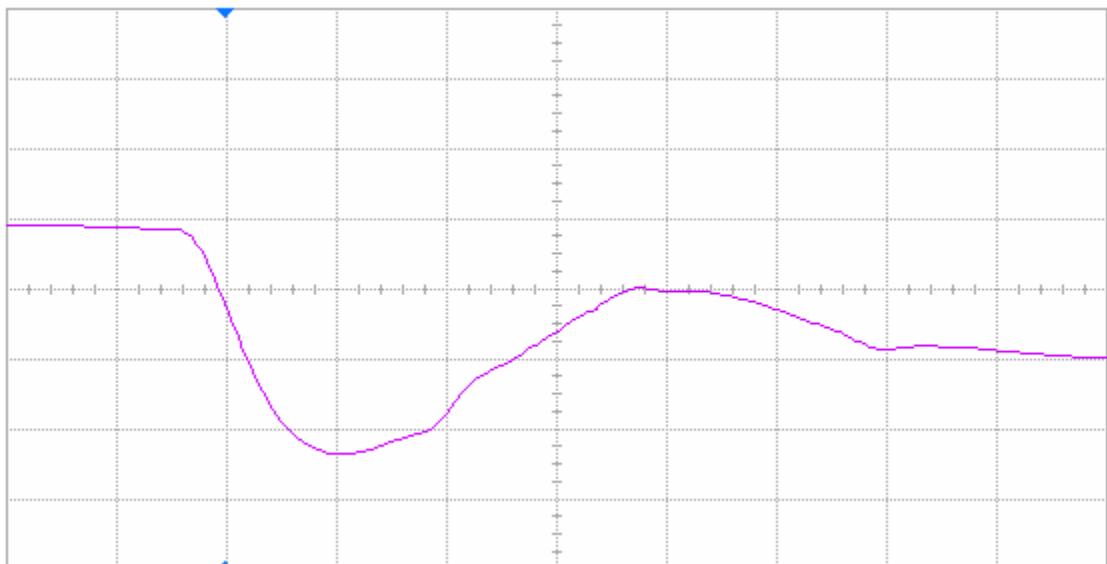


Figure 18(b) DUT 61547 post-annealing falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

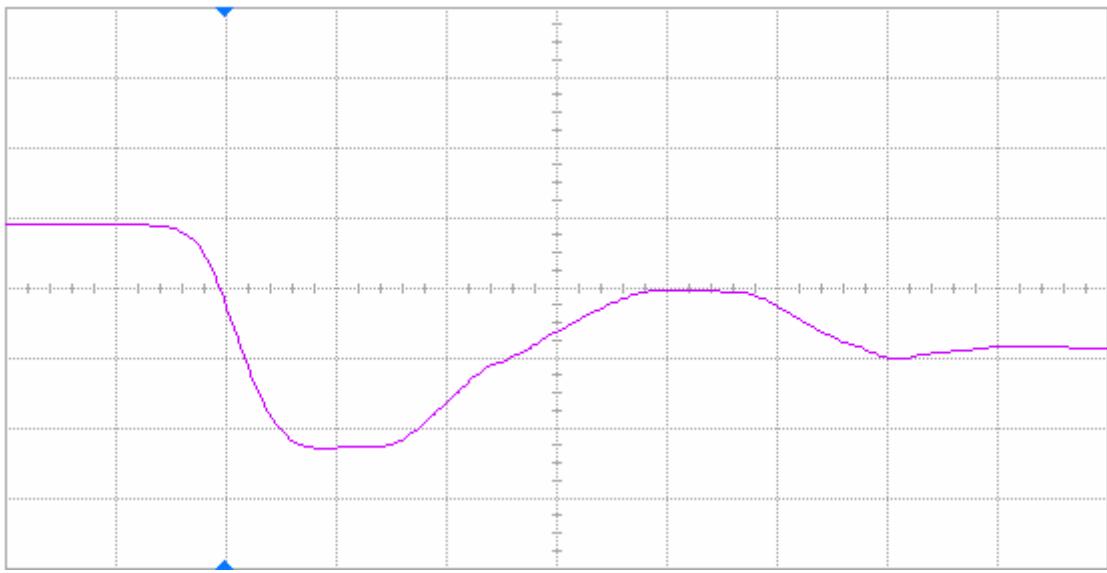


Figure 19(a) DUT 61561 pre-irradiation falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

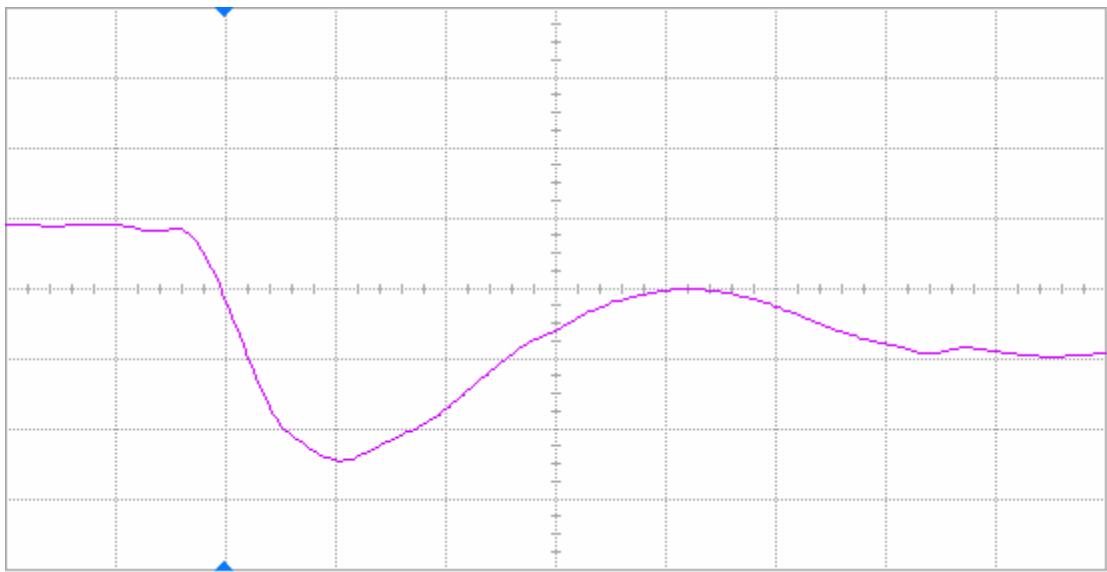
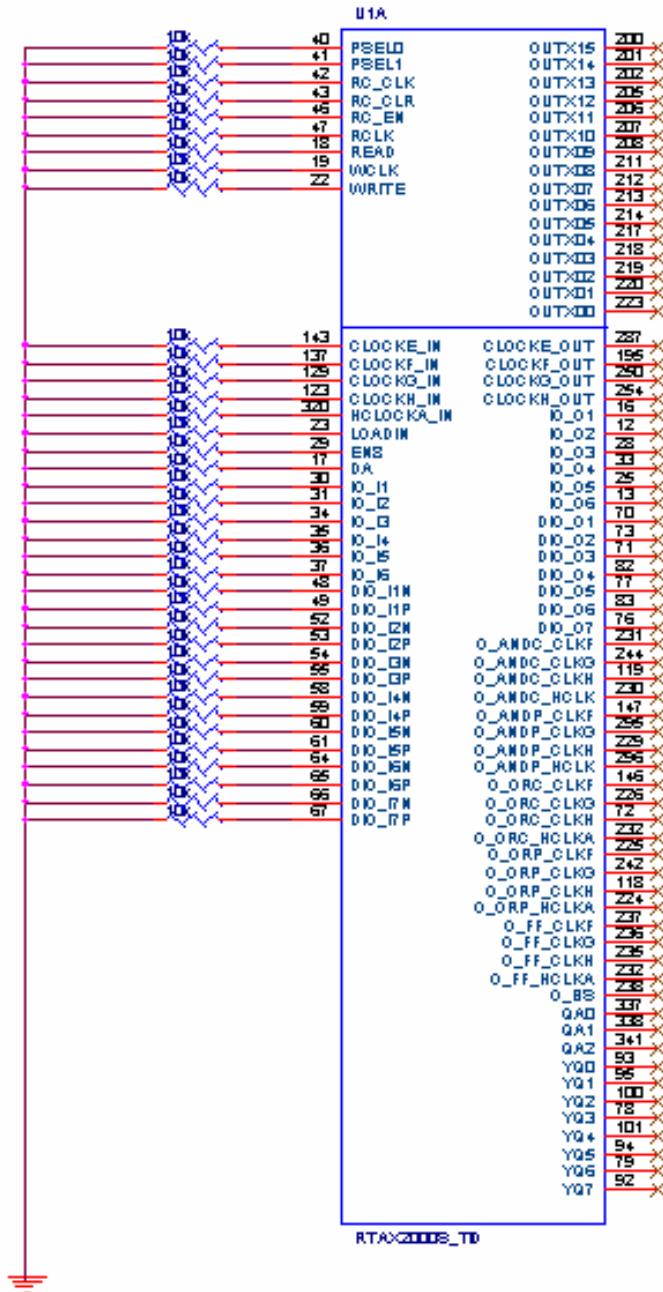
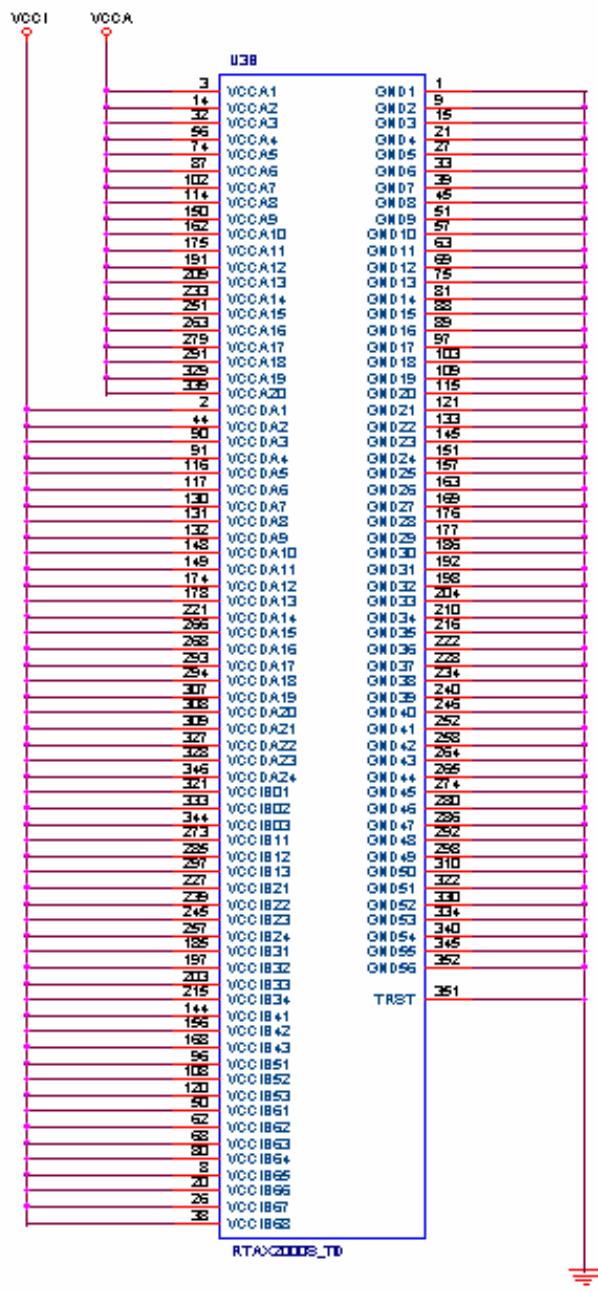


Figure 19(b) DUT 61561 post-annealing falling edge, abscissa scale is 2 V/div and ordinate scale is 2 ns/div.

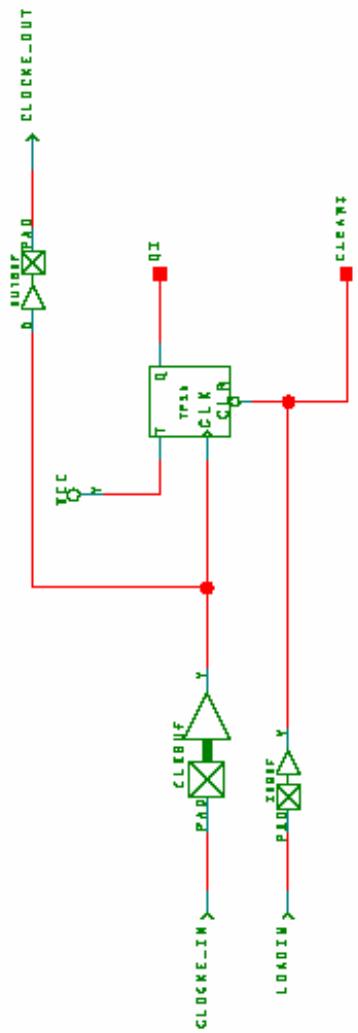
## APPENDIX A DUT BIAS

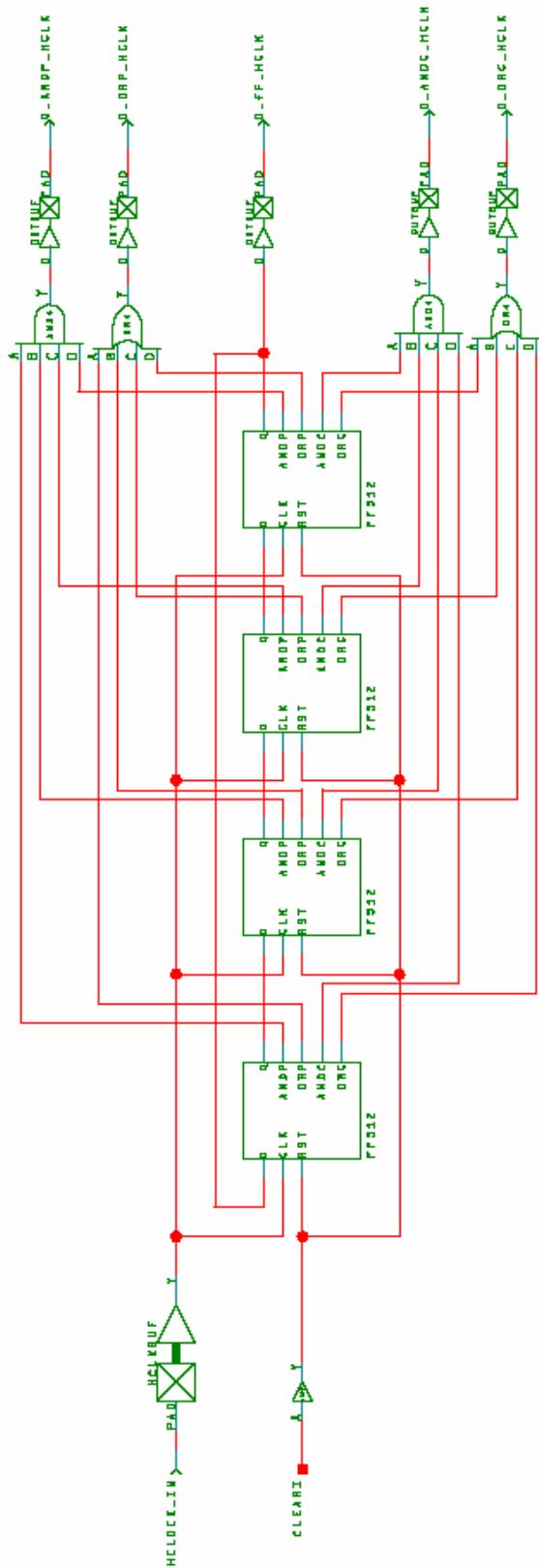




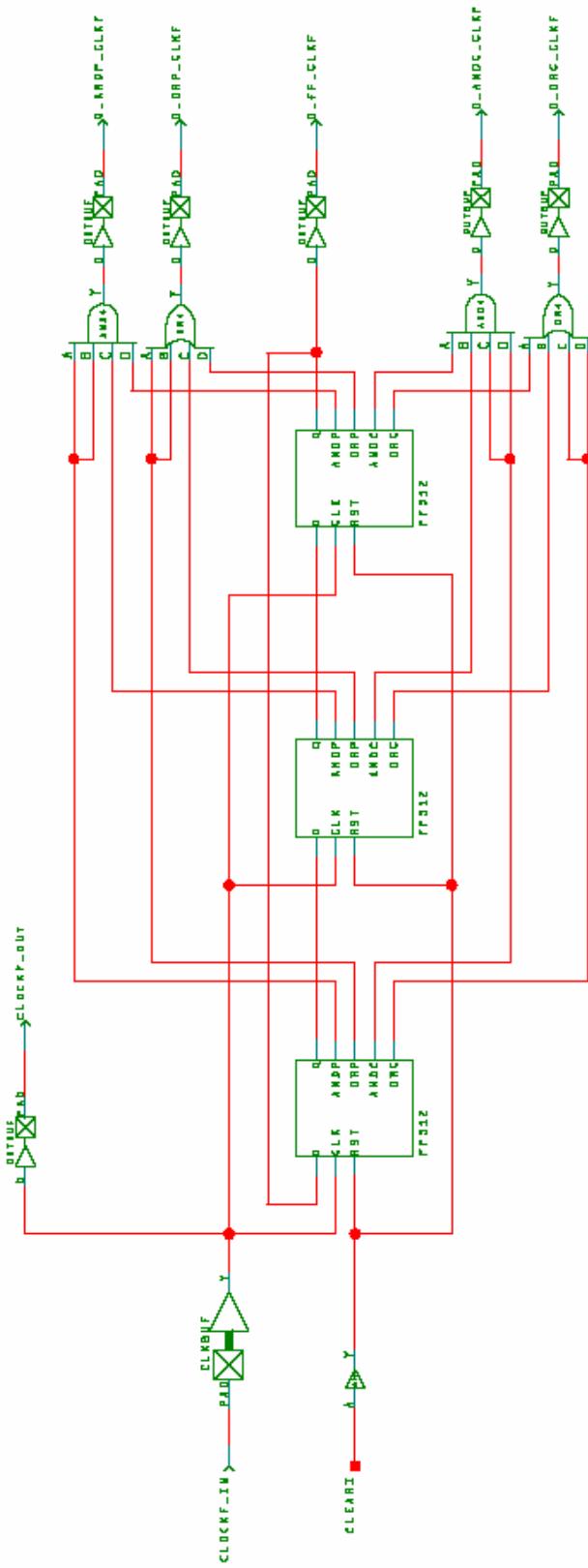
**Figure A2** Power supply, ground and special pins bias during irradiation, RTAX1000S\_TID basically has the same bias configuration as that of the RTAX2000S\_TID shown in this figure.

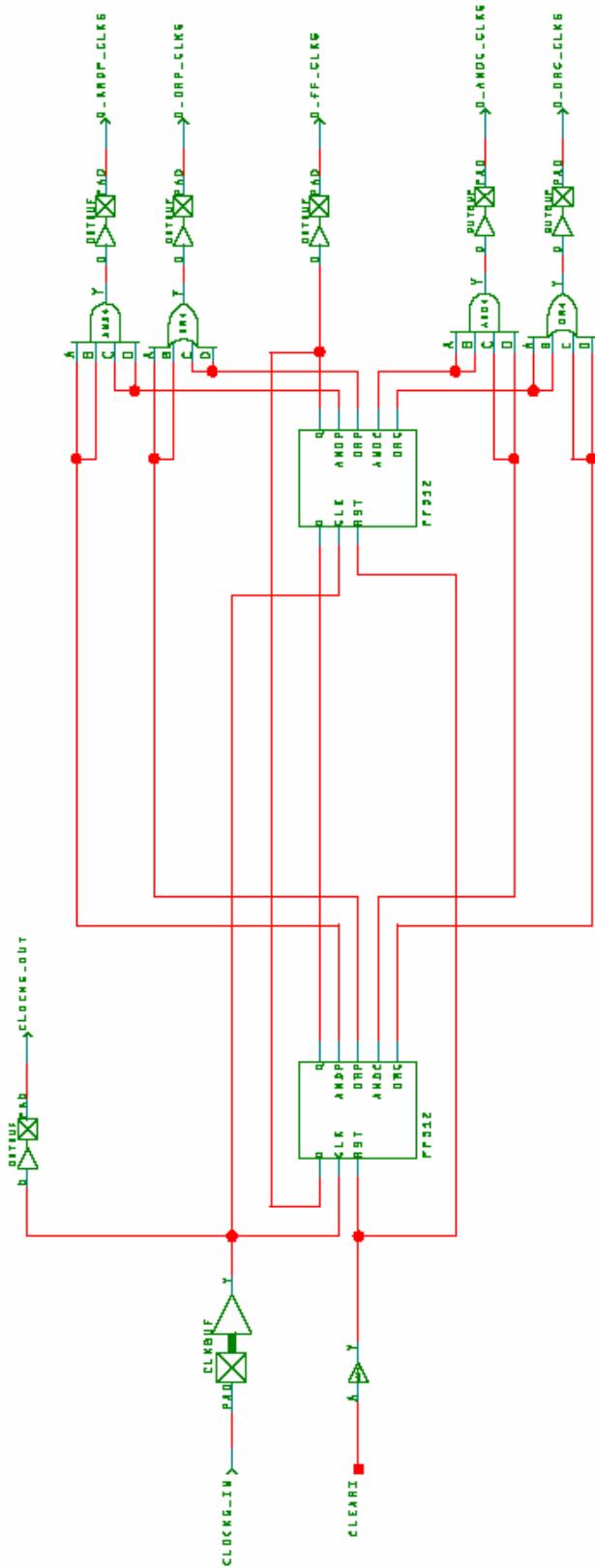
## APPENDIX B DUT DESIGN SCHEMATICS AND VERILOG FILES

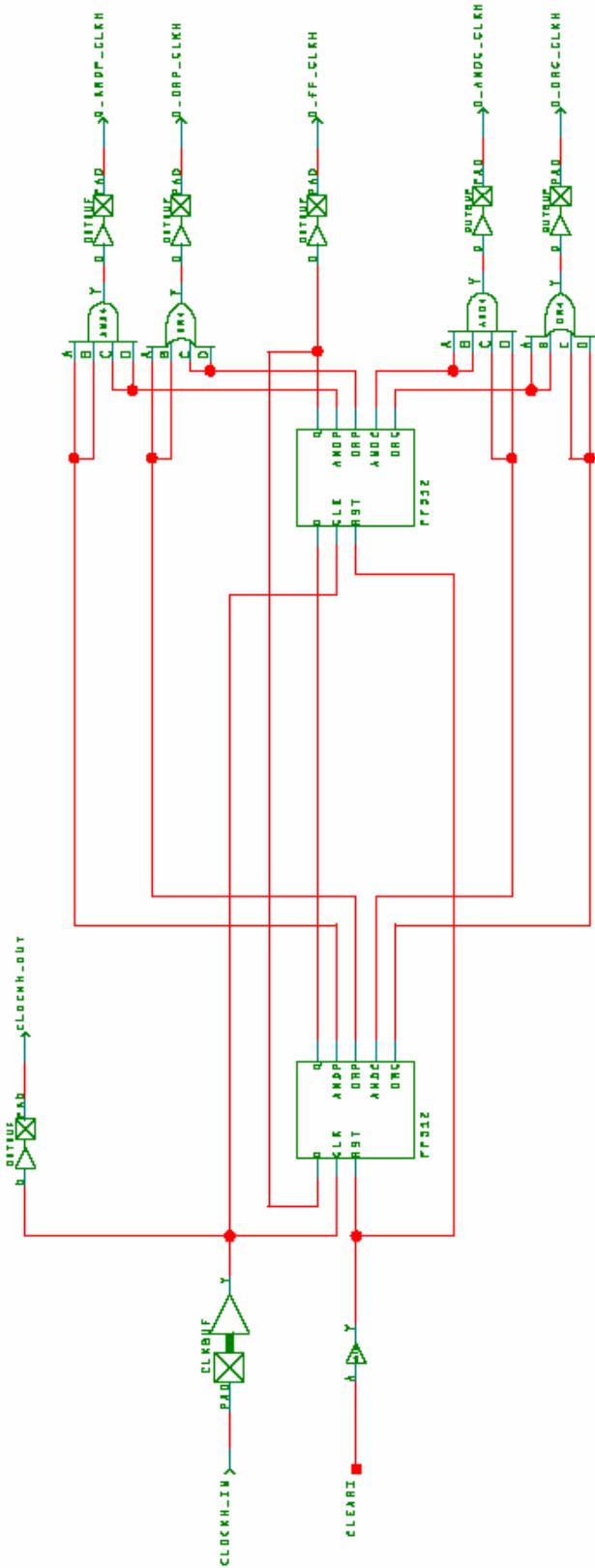


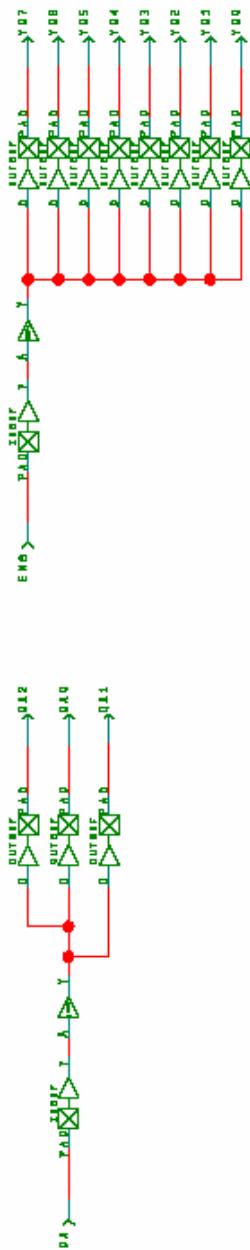


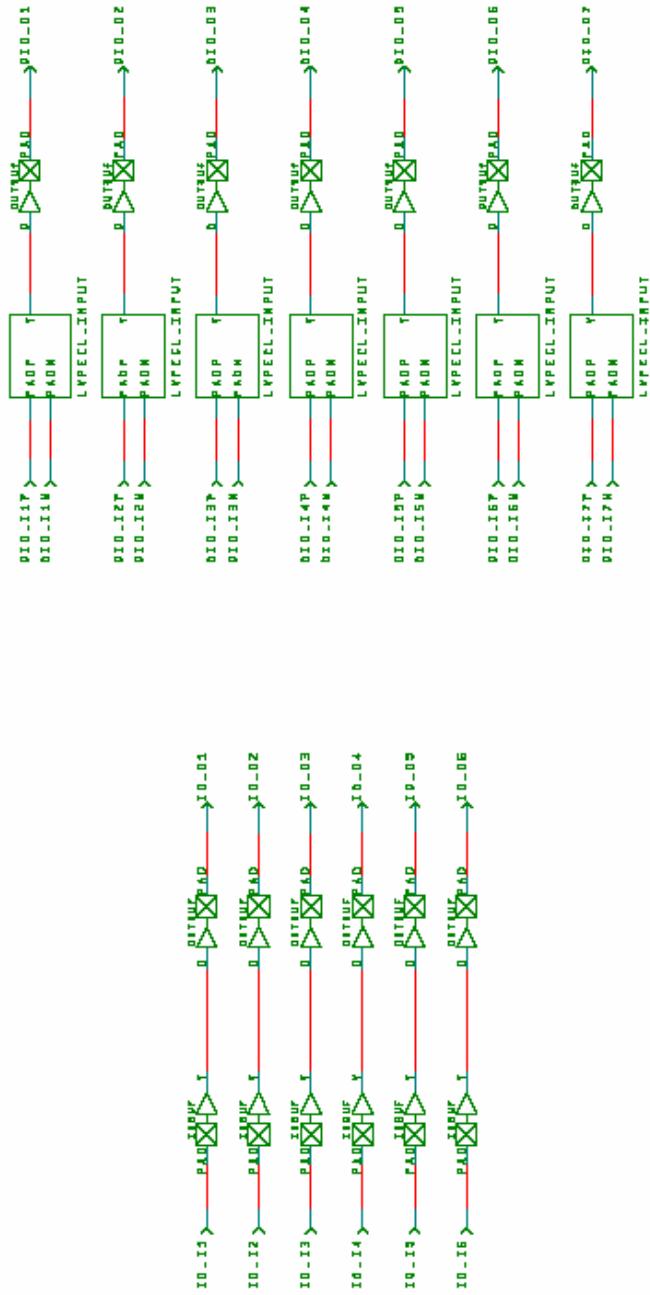












```

//BUFF10k
`timescale 1 ns/100 ps

module BUFF10k (In, Out);

input In;
output Out;

wire x1/*synthesis syn_keep=1 alspreserve=1*/;
wire x2/*synthesis syn_keep=1 alspreserve=1*/;
wire x3/*synthesis syn_keep=1 alspreserve=1*/;
wire x4/*synthesis syn_keep=1 alspreserve=1*/;
wire x5/*synthesis syn_keep=1 alspreserve=1*/;
wire x6/*synthesis syn_keep=1 alspreserve=1*/;
wire x7/*synthesis syn_keep=1 alspreserve=1*/;
wire x8/*synthesis syn_keep=1 alspreserve=1*/;
wire x9/*synthesis syn_keep=1 alspreserve=1*/;

BUFF1k buff1 (.In(In), .Out(x1));
BUFF1k buff2 (.In(x1), .Out(x2));
BUFF1k buff3 (.In(x2), .Out(x3));
BUFF1k buff4 (.In(x3), .Out(x4));
BUFF1k buff5 (.In(x4), .Out(x5));
BUFF1k buff6 (.In(x5), .Out(x6));
BUFF1k buff7 (.In(x6), .Out(x7));
BUFF1k buff8 (.In(x7), .Out(x8));
BUFF1k buff9 (.In(x8), .Out(x9));
BUFF1k buff10 (.In(x9), .Out(Out));

Endmodule

```

```

//BUFF1k
`timescale 1 ns/100 ps

module BUFF1k (In, Out);

input In;
output Out;

wire x1/*synthesis syn_keep=1 alspreserve=1*/;
wire x2/*synthesis syn_keep=1 alspreserve=1*/;
wire x3/*synthesis syn_keep=1 alspreserve=1*/;
wire x4/*synthesis syn_keep=1 alspreserve=1*/;
wire x5/*synthesis syn_keep=1 alspreserve=1*/;
wire x6/*synthesis syn_keep=1 alspreserve=1*/;
wire x7/*synthesis syn_keep=1 alspreserve=1*/;
wire x8/*synthesis syn_keep=1 alspreserve=1*/;
wire x9/*synthesis syn_keep=1 alspreserve=1*/;
wire x10/*synthesis syn_keep=1 alspreserve=1*/;
wire x11/*synthesis syn_keep=1 alspreserve=1*/;
wire x12/*synthesis syn_keep=1 alspreserve=1*/;
wire x13/*synthesis syn_keep=1 alspreserve=1*/;
wire x14/*synthesis syn_keep=1 alspreserve=1*/;
wire x15/*synthesis syn_keep=1 alspreserve=1*/;
wire x16/*synthesis syn_keep=1 alspreserve=1*/;
wire x17/*synthesis syn_keep=1 alspreserve=1*/;
wire x18/*synthesis syn_keep=1 alspreserve=1*/;
wire x19/*synthesis syn_keep=1 alspreserve=1*/;

BUFF50 buff1 (.In(In), .Out(x1));
BUFF50 buff2 (.In(x1), .Out(x2));
BUFF50 buff3 (.In(x2), .Out(x3));
BUFF50 buff4 (.In(x3), .Out(x4));
BUFF50 buff5 (.In(x4), .Out(x5));
BUFF50 buff6 (.In(x5), .Out(x6));
BUFF50 buff7 (.In(x6), .Out(x7));
BUFF50 buff8 (.In(x7), .Out(x8));
BUFF50 buff9 (.In(x8), .Out(x9));
BUFF50 buff10 (.In(x9), .Out(x10));

BUFF50 buff11 (.In(x10), .Out(x11));
BUFF50 buff12 (.In(x11), .Out(x12));
BUFF50 buff13 (.In(x12), .Out(x13));
BUFF50 buff14 (.In(x13), .Out(x14));
BUFF50 buff15 (.In(x14), .Out(x15));
BUFF50 buff16 (.In(x15), .Out(x16));
BUFF50 buff17 (.In(x16), .Out(x17));
BUFF50 buff18 (.In(x17), .Out(x18));
BUFF50 buff19 (.In(x18), .Out(x19));
BUFF50 buff20 (.In(x19), .Out(Out));

endmodule

```

```

//BUFF50
`timescale 1 ns/100 ps

module BUFF50 (In, Out);

input In;
output Out;

wire x1 /*synthesis syn_keep=1 alspreserve=1*/;
wire x2 /*synthesis syn_keep=1 alspreserve=1*/;
wire x3 /*synthesis syn_keep=1 alspreserve=1*/;
wire x4 /*synthesis syn_keep=1 alspreserve=1*/;
wire x5 /*synthesis syn_keep=1 alspreserve=1*/;
wire x6/*synthesis syn_keep=1 alspreserve=1*/;
wire x7/*synthesis syn_keep=1 alspreserve=1*/;
wire x8/*synthesis syn_keep=1 alspreserve=1*/;
wire x9/*synthesis syn_keep=1 alspreserve=1*/;
wire x10/*synthesis syn_keep=1 alspreserve=1*/;
wire x11/*synthesis syn_keep=1 alspreserve=1*/;
wire x12/*synthesis syn_keep=1 alspreserve=1*/;
wire x13/*synthesis syn_keep=1 alspreserve=1*/;
wire x14/*synthesis syn_keep=1 alspreserve=1*/;
wire x15/*synthesis syn_keep=1 alspreserve=1*/;
wire x16/*synthesis syn_keep=1 alspreserve=1*/;
wire x17/*synthesis syn_keep=1 alspreserve=1*/;
wire x18/*synthesis syn_keep=1 alspreserve=1*/;
wire x19/*synthesis syn_keep=1 alspreserve=1*/;
wire x20/*synthesis syn_keep=1 alspreserve=1*/;
wire x21/*synthesis syn_keep=1 alspreserve=1*/;
wire x22/*synthesis syn_keep=1 alspreserve=1*/;
wire x23/*synthesis syn_keep=1 alspreserve=1*/;
wire x24/*synthesis syn_keep=1 alspreserve=1*/;
wire x25/*synthesis syn_keep=1 alspreserve=1*/;
wire x26/*synthesis syn_keep=1 alspreserve=1*/;
wire x27/*synthesis syn_keep=1 alspreserve=1*/;
wire x28/*synthesis syn_keep=1 alspreserve=1*/;
wire x29/*synthesis syn_keep=1 alspreserve=1*/;
wire x30/*synthesis syn_keep=1 alspreserve=1*/;
wire x31/*synthesis syn_keep=1 alspreserve=1*/;
wire x32/*synthesis syn_keep=1 alspreserve=1*/;
wire x33/*synthesis syn_keep=1 alspreserve=1*/;
wire x34/*synthesis syn_keep=1 alspreserve=1*/;
wire x35/*synthesis syn_keep=1 alspreserve=1*/;
wire x36/*synthesis syn_keep=1 alspreserve=1*/;
wire x37/*synthesis syn_keep=1 alspreserve=1*/;
wire x38/*synthesis syn_keep=1 alspreserve=1*/;
wire x39/*synthesis syn_keep=1 alspreserve=1*/;
wire x40/*synthesis syn_keep=1 alspreserve=1*/;
wire x41/*synthesis syn_keep=1 alspreserve=1*/;
wire x42/*synthesis syn_keep=1 alspreserve=1*/;
wire x43/*synthesis syn_keep=1 alspreserve=1*/;
wire x44/*synthesis syn_keep=1 alspreserve=1*/;
wire x45/*synthesis syn_keep=1 alspreserve=1*/;
wire x46/*synthesis syn_keep=1 alspreserve=1*/;

```

```
wire x47/*synthesis syn_keep=1 alspreserve=1*/;
wire x48/*synthesis syn_keep=1 alspreserve=1*/;
wire x49/*synthesis syn_keep=1 alspreserve=1*/;
```

```
BUFF buff1 (.A(In), .Y(x1));
BUFF buff2 (.A(x1), .Y(x2));
BUFF buff3 (.A(x2), .Y(x3));
BUFF buff4 (.A(x3), .Y(x4));
BUFF buff5 (.A(x4), .Y(x5));
BUFF buff6 (.A(x5), .Y(x6));
BUFF buff7 (.A(x6), .Y(x7));
BUFF buff8 (.A(x7), .Y(x8));
BUFF buff9 (.A(x8), .Y(x9));
BUFF buff10 (.A(x9), .Y(x10));
```

```
BUFF buff11 (.A(x10), .Y(x11));
BUFF buff12 (.A(x11), .Y(x12));
BUFF buff13 (.A(x12), .Y(x13));
BUFF buff14 (.A(x13), .Y(x14));
BUFF buff15 (.A(x14), .Y(x15));
BUFF buff16 (.A(x15), .Y(x16));
BUFF buff17 (.A(x16), .Y(x17));
BUFF buff18 (.A(x17), .Y(x18));
BUFF buff19 (.A(x18), .Y(x19));
BUFF buff20 (.A(x19), .Y(x20));
```

```
BUFF buff21 (.A(x20), .Y(x21));
BUFF buff22 (.A(x21), .Y(x22));
BUFF buff23 (.A(x22), .Y(x23));
BUFF buff24 (.A(x23), .Y(x24));
BUFF buff25 (.A(x24), .Y(x25));
BUFF buff26 (.A(x25), .Y(x26));
BUFF buff27 (.A(x26), .Y(x27));
BUFF buff28 (.A(x27), .Y(x28));
BUFF buff29 (.A(x28), .Y(x29));
BUFF buff30 (.A(x29), .Y(x30));
```

```
BUFF buff31 (.A(x30), .Y(x31));
BUFF buff32 (.A(x31), .Y(x32));
BUFF buff33 (.A(x32), .Y(x33));
BUFF buff34 (.A(x33), .Y(x34));
BUFF buff35 (.A(x34), .Y(x35));
BUFF buff36 (.A(x35), .Y(x36));
BUFF buff37 (.A(x36), .Y(x37));
BUFF buff38 (.A(x37), .Y(x38));
BUFF buff39 (.A(x38), .Y(x39));
BUFF buff40 (.A(x39), .Y(x40));
```

```
BUFF buff41 (.A(x40), .Y(x41));
BUFF buff42 (.A(x41), .Y(x42));
BUFF buff43 (.A(x42), .Y(x43));
BUFF buff44 (.A(x43), .Y(x44));
BUFF buff45 (.A(x44), .Y(x45));
BUFF buff46 (.A(x45), .Y(x46));
BUFF buff47 (.A(x46), .Y(x47));
```

```
BUFF buff48 (.A(x47), .Y(x48));  
BUFF buff49 (.A(x48), .Y(x49));  
BUFF buff50 (.A(x49), .Y(Out));
```

```
endmodule
```

```

//FF512
`timescale 1 ns/100 ps
module FF512 (D, Q, CLK, RST, ANDP, ORP, ANDC, ORC);

input D, CLK, RST;
output Q, ANDP, ORP, ANDC, ORC;

wire x1, x2, x3, Q;
wire andp_a, andp_b, andp_c, andp_d, orp_a, orp_b, orp_c, orp_d;
wire andc_a, andc_b, andc_c, andc_d, orc_a, orc_b, orc_c, orc_d;

FF128 dff_a (.D(D), .Q(x1), .CLK(CLK), .RST(RST), .ANDP(andp_a), .ORP(orp_a),
.ANDC(andc_a), .ORC(orc_a));

FF128 dff_b (.D(x1), .Q(x2), .CLK(CLK), .RST(RST), .ANDP(andp_b), .ORP(orp_b),
.ANDC(andc_b), .ORC(orc_b));

FF128 dff_c (.D(x2), .Q(x3), .CLK(CLK), .RST(RST), .ANDP(andp_c), .ORP(orp_c),
.ANDC(andc_c), .ORC(orc_c));

FF128 dff_d (.D(x3), .Q(Q), .CLK(CLK), .RST(RST), .ANDP(andp_d), .ORP(orp_d),
.ANDC(andc_d), .ORC(orc_d));

AND4 and4p (.A(andp_a), .B(andp_b), .C(andp_c), .D(andp_d), .Y(ANDP));
OR4 or4p (.A(orp_a), .B(orp_b), .C(orp_c), .D(orp_d), .Y(ORP));

AND4 and4c (.A(andc_a), .B(andc_b), .C(andc_c), .D(andc_d), .Y(ANDC));
OR4 or4c (.A(orc_a), .B(orc_b), .C(orc_c), .D(orc_d), .Y(ORC));

endmodule

```

```

//FF128
`timescale 1 ns/100 ps
module FF128 (D, Q, CLK, RST, ANDP, ORP, ANDC, ORC);

input D, CLK, RST;
output Q, ANDP, ORP, ANDC, ORC;

wire x1, x2, x3, Q;
wire andp_a, andp_b, andp_c, andp_d, orp_a, orp_b, orp_c, orp_d;
wire andc_a, andc_b, andc_c, andc_d, orc_a, orc_b, orc_c, orc_d;

FF32 dff_a (.D(D), .Q(x1), .CLK(CLK), .RST(RST), .ANDP(andp_a), .ORP(orp_a),
.ANDC(andc_a), .ORC(orc_a));

FF32 dff_b (.D(x1), .Q(x2), .CLK(CLK), .RST(RST), .ANDP(andp_b), .ORP(orp_b),
.ANDC(andc_b), .ORC(orc_b));

FF32 dff_c (.D(x2), .Q(x3), .CLK(CLK), .RST(RST), .ANDP(andp_c), .ORP(orp_c),
.ANDC(andc_c), .ORC(orc_c));

FF32 dff_d (.D(x3), .Q(Q), .CLK(CLK), .RST(RST), .ANDP(andp_d), .ORP(orp_d),
.ANDC(andc_d), .ORC(orc_d));

AND4 and4p (.A(andp_a), .B(andp_b), .C(andp_c), .D(andp_d), .Y(ANDP));
OR4 or4p (.A(orp_a), .B(orp_b), .C(orp_c), .D(orp_d), .Y(ORP));

AND4 and4c (.A(andc_a), .B(andc_b), .C(andc_c), .D(andc_d), .Y(ANDC));
OR4 or4c (.A(orc_a), .B(orc_b), .C(orc_c), .D(orc_d), .Y(ORC));

endmodule

```

```

//FF32
`timescale 1 ns/100 ps
module FF32 (D, Q, CLK, RST, ANDP, ORP, ANDC, ORC);

input D, CLK, RST;
output Q, ANDP, ORP, ANDC, ORC;

wire x1, x2, x3, Q;
wire andp_a, andp_b, andp_c, andp_d, orp_a, orp_b, orp_c, orp_d;
wire andc_a, andc_b, andc_c, andc_d, orc_a, orc_b, orc_c, orc_d;

FF8 dff_a (.D(D), .Q(x1), .CLK(CLK), .RST(RST), .ANDP(andp_a), .ORP(orp_a),
.ANDC(andc_a), .ORC(orc_a));

FF8 dff_b (.D(x1), .Q(x2), .CLK(CLK), .RST(RST), .ANDP(andp_b), .ORP(orp_b),
.ANDC(andc_b), .ORC(orc_b));

FF8 dff_c (.D(x2), .Q(x3), .CLK(CLK), .RST(RST), .ANDP(andp_c), .ORP(orp_c),
.ANDC(andc_c), .ORC(orc_c));

FF8 dff_d (.D(x3), .Q(Q), .CLK(CLK), .RST(RST), .ANDP(andp_d), .ORP(orp_d),
.ANDC(andc_d), .ORC(orc_d));

AND4 and4p (.A(andp_a), .B(andp_b), .C(andp_c), .D(andp_d), .Y(ANDP));
OR4 or4p (.A(orp_a), .B(orp_b), .C(orp_c), .D(orp_d), .Y(ORP));

AND4 and4c (.A(andc_a), .B(andc_b), .C(andc_c), .D(andc_d), .Y(ANDC));
OR4 or4c (.A(orc_a), .B(orc_b), .C(orc_c), .D(orc_d), .Y(ORC));

endmodule

```

```

//FF8
`timescale 1 ns/100 ps

module FF8 (D, Q, CLK, RST, ANDP, ORP, ANDC, ORC);

input D, CLK, RST;
output Q, ANDP, ORP, ANDC, ORC;

wire x1, x2, x3, x4, x5, x6, x7;

DFC1B dff1 (.D(D), .Q(x1), .CLK(CLK), .CLR(RST));
DFP1B dff2 (.D(x1), .Q(x2), .CLK(CLK), .PRE(RST));
DFC1B dff3 (.D(x2), .Q(x3), .CLK(CLK), .CLR(RST));
DFP1B dff4 (.D(x3), .Q(x4), .CLK(CLK), .PRE(RST));
DFC1B dff5 (.D(x4), .Q(x5), .CLK(CLK), .CLR(RST));
DFP1B dff6 (.D(x5), .Q(x6), .CLK(CLK), .PRE(RST));
DFC1B dff7 (.D(x6), .Q(x7), .CLK(CLK), .CLR(RST));
DFP1B dff8 (.D(x7), .Q(Q), .CLK(CLK), .PRE(RST));

AND4 and4p (.A(x2), .B(x4), .C(x6), .D(Q), .Y(ANDP));
OR4 or4p (.A(x2), .B(x4), .C(x6), .D(Q), .Y(ORP));

AND4 and4c (.A(x1), .B(x3), .C(x5), .D(x7), .Y(ANDC));
OR4 or4c (.A(x1), .B(x3), .C(x5), .D(x7), .Y(ORC));

endmodule

```

```

`timescale 1 ns/100 ps
// Top_RAM_2048x9.v

module Top_RAM_2048x9(Psel0, Psel1, RC_en, RC_clr, RC_clk, Write, Read, Wclk, Rclk,
                      Q_RAM);
input Psel0, Psel1, RC_en, RC_clr, RC_clk, Write, Read, Wclk, Rclk;
output [8:0] Q_RAM;

wire Gnd, Vcc;
wire mx0, mx1;
wire [13:0] rc;
wire [7:0] dec;
wire y_0w, y_0r, y_1w, y_1r, y_2w, y_2r, y_3w, y_3r, y_4w, y_4r, y_5w, y_5r,
      y_6w, y_6r, y_7w, y_7r;
wire [8:0] DIN;
wire [8:0] Q_b0;
wire [8:0] Q_b1;
wire [8:0] Q_b2;
wire [8:0] Q_b3;
wire [8:0] Q_b4;
wire [8:0] Q_b5;
wire [8:0] Q_b6;
wire [8:0] Q_b7;

GND gnd_0(.Y(Gnd));
VCC vcc_0(.Y(Vcc));

mux_2x1 mux_0(.Data0_port(Gnd), .Data1_port(Vcc), .Sel0(Psel0), .Result(mx0));
mux_2x1 mux_1(.Data0_port(Gnd), .Data1_port(Vcc), .Sel0(Psel1), .Result(mx1));

counter_14 counter_0(.Enable(RC_en), .Aclr(RC_clr), .Clock(RC_clk), .Q(rc));

decoder_3x8 decoder_0(.Data0(rc[11]), .Data1(rc[12]), .Data2(rc[13]), .Eq(dec));

NAND2 nand_0w(.A(dec[0]), .B(Write), .Y(y_0w));
NAND2 nand_0r(.A(dec[0]), .B(Read), .Y(y_0r));

ram_2048x9 ram_blk0(.Data(DIN), .Q(Q_b0), .WAddress(rc[10:0]), .RAddress(rc[10:0]),
                     .WE(y_0w), .RE(y_0r), .WClock(Wclk), .RClock(Rclk));

assign DIN[0]=mx0, DIN[1]=mx1, DIN[2]=mx0, DIN[3]=mx1, DIN[4]=mx0, DIN[5]=mx1,
      DIN[6]=mx0, DIN[7]=mx1, DIN[8]=mx0;
NAND2 nand_1w(.A(dec[1]), .B(Write), .Y(y_1w));
NAND2 nand_1r(.A(dec[1]), .B(Read), .Y(y_1r));

ram_2048x9 ram_blk1(.Data(DIN), .Q(Q_b1), .WAddress(rc[10:0]), .RAddress(rc[10:0]),
                     .WE(y_1w), .RE(y_1r), .WClock(Wclk), .RClock(Rclk));

NAND2 nand_2w(.A(dec[2]), .B(Write), .Y(y_2w));
NAND2 nand_2r(.A(dec[2]), .B(Read), .Y(y_2r));

ram_2048x9 ram_blk2(.Data(DIN),
                     .Q(Q_b2), .WAddress(rc[10:0]), .RAddress(rc[10:0]),
                     .WE(y_2w), .RE(y_2r), .WClock(Wclk), .RClock(Rclk));

```

```

NAND2 nand_3w(.A(dec[3]), .B(Write), .Y(y_3w));
NAND2 nand_3r(.A(dec[3]), .B(Read), .Y(y_3r));

ram_2048x9 ram_blk3(.Data(DIN),
.Q(Q_b3), .WAddress(rc[10:0]), .RAddress(rc[10:0]),
.WE(y_3w), .RE(y_3r), .WClock(Wclk), .RClock(Rclk));

NAND2 nand_4w(.A(dec[4]), .B(Write), .Y(y_4w));
NAND2 nand_4r(.A(dec[4]), .B(Read), .Y(y_4r));

ram_2048x9 ram_blk4(.Data(DIN),
.Q(Q_b4), .WAddress(rc[10:0]), .RAddress(rc[10:0]),
.WE(y_4w), .RE(y_4r), .WClock(Wclk), .RClock(Rclk));

NAND2 nand_5w(.A(dec[5]), .B(Write), .Y(y_5w));
NAND2 nand_5r(.A(dec[5]), .B(Read), .Y(y_5r));

ram_2048x9 ram_blk5(.Data(DIN),
.Q(Q_b5), .WAddress(rc[10:0]), .RAddress(rc[10:0]),
.WE(y_5w), .RE(y_5r), .WClock(Wclk), .RClock(Rclk));

NAND2 nand_6w(.A(dec[6]), .B(Write), .Y(y_6w));
NAND2 nand_6r(.A(dec[6]), .B(Read), .Y(y_6r));

ram_2048x9 ram_blk6(.Data(DIN),
.Q(Q_b6), .WAddress(rc[10:0]), .RAddress(rc[10:0]),
.WE(y_6w), .RE(y_6r), .WClock(Wclk), .RClock(Rclk));

NAND2 nand_7w(.A(dec[7]), .B(Write), .Y(y_7w));
NAND2 nand_7r(.A(dec[7]), .B(Read), .Y(y_7r));

ram_2048x9 ram_blk7(.Data(DIN),
.Q(Q_b7), .WAddress(rc[10:0]), .RAddress(rc[10:0]),
.WE(y_7w), .RE(y_7r), .WClock(Wclk), .RClock(Rclk));

mux_9x8 mux_9x8_0(.Data0_port(Q_b0), .Data1_port(Q_b1), .Data2_port(Q_b2),
.Data3_port(Q_b3), .Data4_port(Q_b4), .Data5_port(Q_b5),
.Data6_port(Q_b6), .Data7_port(Q_b7), .Sel0(rc[11]),
.Sel1(rc[12]), .Sel2(rc[13]), .Result(Q_RAM));

endmodule

```

```
`timescale 1 ns/100 ps
//Version: 6.0 SP3 6.0.30.3

module mux_2x1(Data0_port,Data1_port,Sel0,Result);
input Data0_port, Data1_port, Sel0;
output Result;

MX2 MX2_Result(.A(Data0_port), .B(Data1_port), .S(Sel0), .Y(
    Result));

endmodule
```

```

`timescale 1 ns/100 ps
// Version: Designer v5.0 5.0.0.10

module counter_14(Enable,Aclr,Clock,Q);
input Enable, Aclr, Clock;
output [13:0] Q;

wire ClrAux_0_net, ClrAux_7_net, MX2_1_Y, MX2_8_Y, MX2_5_Y,
      CM8_0_Y, MX2_11_Y, MX2_10_Y, MX2_4_Y, MX2_6_Y, MX2_7_Y,
      MX2_0_Y, MX2_3_Y, MX2_9_Y, MX2_2_Y, MX2_12_Y, VCC, GND;

VCC VCC_1_net(.Y(VCC));
GND GND_1_net(.Y(GND));
DFC1D DFC1D_Q_7_inst(.D(MX2_1_Y), .CLK(Q[6]), .CLR(
    ClrAux_7_net), .Q(Q[7]));
DFC1D DFC1D_Q_1_inst(.D(MX2_8_Y), .CLK(Q[0]), .CLR(
    ClrAux_0_net), .Q(Q[1]));
BUFF BUFF_ClrAux_0_inst(.A(Aclr), .Y(ClrAux_0_net));
MX2 MX2_9(.A(VCC), .B(GND), .S(Q[9]), .Y(MX2_9_Y));
DFC1D DFC1D_Q_2_inst(.D(MX2_7_Y), .CLK(Q[1]), .CLR(
    ClrAux_0_net), .Q(Q[2]));
MX2 MX2_0(.A(VCC), .B(GND), .S(Q[8]), .Y(MX2_0_Y));
DFC1D DFC1D_Q_12_inst(.D(MX2_5_Y), .CLK(Q[11]), .CLR(
    ClrAux_7_net), .Q(Q[12]));
DFC1D DFC1D_Q_3_inst(.D(MX2_12_Y), .CLK(Q[2]), .CLR(
    ClrAux_0_net), .Q(Q[3]));
DFC1D DFC1D_Q_4_inst(.D(MX2_6_Y), .CLK(Q[3]), .CLR(
    ClrAux_0_net), .Q(Q[4]));
CM8 CM8_0(.D0(GND), .D1(VCC), .D2(VCC), .D3(GND), .S00(Q[0]),
    .S01(VCC), .S10(Enable), .S11(GND), .Y(CM8_0_Y));
MX2 MX2_11(.A(VCC), .B(GND), .S(Q[11]), .Y(MX2_11_Y));
DFC1B DFC1B_Q_0_inst(.D(CM8_0_Y), .CLK(Clock), .CLR(
    ClrAux_0_net), .Q(Q[0]));
MX2 MX2_6(.A(VCC), .B(GND), .S(Q[4]), .Y(MX2_6_Y));
DFC1D DFC1D_Q_11_inst(.D(MX2_11_Y), .CLK(Q[10]), .CLR(
    ClrAux_7_net), .Q(Q[11]));
MX2 MX2_3(.A(VCC), .B(GND), .S(Q[13]), .Y(MX2_3_Y));
MX2 MX2_10(.A(VCC), .B(GND), .S(Q[5]), .Y(MX2_10_Y));
BUFF BUFF_ClrAux_7_inst(.A(Aclr), .Y(ClrAux_7_net));
MX2 MX2_4(.A(VCC), .B(GND), .S(Q[10]), .Y(MX2_4_Y));
DFC1D DFC1D_Q_5_inst(.D(MX2_10_Y), .CLK(Q[4]), .CLR(
    ClrAux_0_net), .Q(Q[5]));
DFC1D DFC1D_Q_9_inst(.D(MX2_9_Y), .CLK(Q[8]), .CLR(
    ClrAux_7_net), .Q(Q[9]));
MX2 MX2_5(.A(VCC), .B(GND), .S(Q[12]), .Y(MX2_5_Y));
MX2 MX2_8(.A(VCC), .B(GND), .S(Q[1]), .Y(MX2_8_Y));
DFC1D DFC1D_Q_8_inst(.D(MX2_0_Y), .CLK(Q[7]), .CLR(
    ClrAux_7_net), .Q(Q[8]));
MX2 MX2_2(.A(VCC), .B(GND), .S(Q[6]), .Y(MX2_2_Y));
MX2 MX2_7(.A(VCC), .B(GND), .S(Q[2]), .Y(MX2_7_Y));
MX2 MX2_1(.A(VCC), .B(GND), .S(Q[7]), .Y(MX2_1_Y));
DFC1D DFC1D_Q_6_inst(.D(MX2_2_Y), .CLK(Q[5]), .CLR(
    ClrAux_0_net), .Q(Q[6]));
DFC1D DFC1D_Q_13_inst(.D(MX2_3_Y), .CLK(Q[12]), .CLR(
    ClrAux_7_net), .Q(Q[13]));

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DFC1D DFC1D_Q_10_inst(.D(MX2_4_Y), .CLK(Q[9]), .CLR(
    ClrAux_7_net), .Q(Q[10]));
MX2 MX2_12(.A(VCC), .B(GND), .S(Q[3]), .Y(MX2_12_Y));

endmodule
```

```

`timescale 1 ns/100 ps
// Version: 6.0 SP3 6.0.30.3

module decoder_3x8(Data0,Data1,Data2,Eq);
input Data0, Data1, Data2;
output [7:0] Eq;

AND3A AND3A_Eq_3_inst(.A(Data2), .B(Data0), .C(Data1), .Y(
    Eq[3]));
AND3 AND3_Eq_7_inst(.A(Data1), .B(Data0), .C(Data2), .Y(Eq[7])
    );
AND3B AND3B_Eq_4_inst(.A(Data0), .B(Data1), .C(Data2), .Y(
    Eq[4]));
AND3A AND3A_Eq_5_inst(.A(Data1), .B(Data0), .C(Data2), .Y(
    Eq[5]));
AND3B AND3B_Eq_1_inst(.A(Data1), .B(Data2), .C(Data0), .Y(
    Eq[1]));
AND3A AND3A_Eq_6_inst(.A(Data0), .B(Data1), .C(Data2), .Y(
    Eq[6]));
AND3B AND3B_Eq_2_inst(.A(Data0), .B(Data2), .C(Data1), .Y(
    Eq[2]));
AND3C AND3C_Eq_0_inst(.A(Data0), .B(Data1), .C(Data2), .Y(
    Eq[0]));

endmodule

```

```

`timescale 1 ns/100 ps
// Version: 6.1 SP1 6.1.1.108

module ram_2048x9(Data,Q,WAddress,RAddress,WE,RE,WClock,RClock);
input [8:0] Data;
output [8:0] Q;
input [10:0] WAddress, RAddress;
input WE, RE, WClock, RClock;

wire INV_1_Y, INV_0_Y, VCC, GND;

VCC VCC_1_net(.Y(VCC));
GND GND_1_net(.Y(GND));
INV INV_0(.A(RE), .Y(INV_0_Y));
INV INV_1(.A(WE), .Y(INV_1_Y));
RAM64K36P RAM64K36P_Q_0_inst(.WCLK(WClock), .RCLK(RClock),
    .DEPTH0(VCC), .DEPTH1(VCC), .DEPTH2(GND), .DEPTH3(GND),
    .WEN(INV_1_Y), .WW0(VCC), .WW1(VCC), .WW2(GND), .WRAD0(
    WAddress[0]), .WRAD1(WAddress[1]), .WRAD2(WAddress[2]),
    .WRAD3(WAddress[3]), .WRAD4(WAddress[4]), .WRAD5(
    WAddress[5]), .WRAD6(WAddress[6]), .WRAD7(WAddress[7]),
    .WRAD8(WAddress[8]), .WRAD9(WAddress[9]), .WRAD10(
    WAddress[10]), .WRAD11(GND), .WRAD12(GND), .WRAD13(GND),
    .WRAD14(GND), .WRAD15(GND), .WD0(Data[0]), .WD1(Data[1]),
    .WD2(Data[2]), .WD3(Data[3]), .WD4(Data[4]), .WD5(Data[5])
    , .WD6(Data[6]), .WD7(Data[7]), .WD8(Data[8]), .WD9(GND),
    .WD10(GND), .WD11(GND), .WD12(GND), .WD13(GND), .WD14(GND)
    , .WD15(GND), .WD16(GND), .WD17(GND), .WD18(GND), .WD19(
    GND), .WD20(GND), .WD21(GND), .WD22(GND), .WD23(GND),
    .WD24(GND), .WD25(GND), .WD26(GND), .WD27(GND), .WD28(GND)
    , .WD29(GND), .WD30(GND), .WD31(GND), .WD32(GND), .WD33(
    GND), .WD34(GND), .WD35(GND), .REN(INV_0_Y), .RW0(VCC),
    .RW1(VCC), .RW2(GND), .RDAD0(RAddress[0]), .RDAD1(
    RAddress[1]), .RDAD2(RAddress[2]), .RDAD3(RAddress[3]),
    .RDAD4(RAddress[4]), .RDAD5(RAddress[5]), .RDAD6(
    RAddress[6]), .RDAD7(RAddress[7]), .RDAD8(RAddress[8]),
    .RDAD9(RAddress[9]), .RDAD10(RAddress[10]), .RDAD11(GND),
    .RDAD12(GND), .RDAD13(GND), .RDAD14(GND), .RDAD15(GND),
    .RD0(Q[0]), .RD1(Q[1]), .RD2(Q[2]), .RD3(Q[3]), .RD4(Q[4])
    , .RD5(Q[5]), .RD6(Q[6]), .RD7(Q[7]), .RD8(Q[8]), .RD9(),
    .RD10(), .RD11(), .RD12(), .RD13(), .RD14(), .RD15(),
    .RD16(), .RD17(), .RD18(), .RD19(), .RD20(), .RD21(),
    .RD22(), .RD23(), .RD24(), .RD25(), .RD26(), .RD27(),
    .RD28(), .RD29(), .RD30(), .RD31(), .RD32(), .RD33(),
    .RD34(), .RD35());
```

endmodule

```

`timescale 1 ns/100 ps
// Version: 6.1 SP1 6.1.1.108
module mux_9x8(Data0_port,Data1_port,Data2_port,Data3_port,
    Data4_port,Data5_port,Data6_port,Data7_port,Sel0,Sel1,
    Sel2,Result);
input [8:0] Data0_port, Data1_port, Data2_port, Data3_port,
    Data4_port, Data5_port, Data6_port, Data7_port;
input Sel0, Sel1, Sel2;
output [8:0] Result;

wire SelAux_0_0_net, SelAux_0_6_net, SelAux_0_12_net,
    SelAux_1_0_net, SelAux_1_6_net, SelAux_1_12_net,
    SelAux_2_0_net, SelAux_2_5_net, MX4_17_Y, MX4_6_Y,
    MX4_14_Y, MX4_8_Y, MX4_11_Y, MX4_0_Y, MX4_12_Y, MX4_9_Y,
    MX4_13_Y, MX4_7_Y, MX4_2_Y, MX4_4_Y, MX4_5_Y, MX4_1_Y,
    MX4_16_Y, MX4_3_Y, MX4_15_Y, MX4_10_Y;

MX4 MX4_17(.D0(Data0_port[0]), .D1(Data1_port[0]), .D2(
    Data2_port[0]), .D3(Data3_port[0]), .S0(SelAux_0_0_net),
    .S1(SelAux_1_0_net), .Y(MX4_17_Y));
MX4 MX4_15(.D0(Data4_port[7]), .D1(Data5_port[7]), .D2(
    Data6_port[7]), .D3(Data7_port[7]), .S0(SelAux_0_12_net),
    .S1(SelAux_1_12_net), .Y(MX4_15_Y));
MX2 MX2_Result_3_inst(.A(MX4_8_Y), .B(MX4_5_Y), .S(
    SelAux_2_0_net), .Y(Result[3]));
BUFF BUFF_SelAux_0_6_inst(.A(Sel0), .Y(SelAux_0_6_net));
MX4 MX4_16(.D0(Data4_port[5]), .D1(Data5_port[5]), .D2(
    Data6_port[5]), .D3(Data7_port[5]), .S0(SelAux_0_6_net),
    .S1(SelAux_1_6_net), .Y(MX4_16_Y));
MX2 MX2_Result_6_inst(.A(MX4_12_Y), .B(MX4_3_Y), .S(
    SelAux_2_5_net), .Y(Result[6]));
MX4 MX4_13(.D0(Data0_port[8]), .D1(Data1_port[8]), .D2(
    Data2_port[8]), .D3(Data3_port[8]), .S0(SelAux_0_12_net),
    .S1(SelAux_1_12_net), .Y(MX4_13_Y));
MX4 MX4_1(.D0(Data4_port[4]), .D1(Data5_port[4]), .D2(
    Data6_port[4]), .D3(Data7_port[4]), .S0(SelAux_0_6_net),
    .S1(SelAux_1_6_net), .Y(MX4_1_Y));
MX4 MX4_14(.D0(Data0_port[2]), .D1(Data1_port[2]), .D2(
    Data2_port[2]), .D3(Data3_port[2]), .S0(SelAux_0_0_net),
    .S1(SelAux_1_0_net), .Y(MX4_14_Y));
MX4 MX4_9(.D0(Data0_port[7]), .D1(Data1_port[7]), .D2(
    Data2_port[7]), .D3(Data3_port[7]), .S0(SelAux_0_12_net),
    .S1(SelAux_1_12_net), .Y(MX4_9_Y));
BUFF BUFF_SelAux_2_5_inst(.A(Sel2), .Y(SelAux_2_5_net));
BUFF BUFF_SelAux_1_0_inst(.A(Sel1), .Y(SelAux_1_0_net));
MX4 MX4_12(.D0(Data0_port[6]), .D1(Data1_port[6]), .D2(
    Data2_port[6]), .D3(Data3_port[6]), .S0(SelAux_0_12_net),
    .S1(SelAux_1_12_net), .Y(MX4_12_Y));
MX4 MX4_8(.D0(Data0_port[3]), .D1(Data1_port[3]), .D2(
    Data2_port[3]), .D3(Data3_port[3]), .S0(SelAux_0_6_net),
    .S1(SelAux_1_6_net), .Y(MX4_8_Y));
MX2 MX2_Result_8_inst(.A(MX4_13_Y), .B(MX4_10_Y), .S(
    SelAux_2_5_net), .Y(Result[8]));
MX4 MX4_4(.D0(Data4_port[2]), .D1(Data5_port[2]), .D2(
    Data6_port[2]), .D3(Data7_port[2]), .S0(SelAux_0_0_net),

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.S1(SelAux_1_0_net), .Y(MX4_4_Y));
MX2 MX2_Result_0_inst(.A(MX4_17_Y), .B(MX4_7_Y), .S(
    SelAux_2_0_net), .Y(Result[0]));
MX2 MX2_Result_2_inst(.A(MX4_14_Y), .B(MX4_4_Y), .S(
    SelAux_2_0_net), .Y(Result[2]));
BUFF BUFF_SelAux_1_12_inst(.A(Sel1), .Y(SelAux_1_12_net));
MX4 MX4_11(.D0(Data0_port[4]), .D1(Data1_port[4]), .D2(
    Data2_port[4]), .D3(Data3_port[4]), .S0(SelAux_0_6_net),
    .S1(SelAux_1_6_net), .Y(MX4_11_Y));
BUFF BUFF_SelAux_2_0_inst(.A(Sel2), .Y(SelAux_2_0_net));
BUFF BUFF_SelAux_0_0_inst(.A(Sel0), .Y(SelAux_0_0_net));
MX2 MX2_Result_5_inst(.A(MX4_0_Y), .B(MX4_16_Y), .S(
    SelAux_2_5_net), .Y(Result[5]));
MX2 MX2_Result_1_inst(.A(MX4_6_Y), .B(MX4_2_Y), .S(
    SelAux_2_0_net), .Y(Result[1]));
MX4 MX4_10(.D0(Data4_port[8]), .D1(Data5_port[8]), .D2(
    Data6_port[8]), .D3(Data7_port[8]), .S0(SelAux_0_12_net),
    .S1(SelAux_1_12_net), .Y(MX4_10_Y));
MX4 MX4_7(.D0(Data4_port[0]), .D1(Data5_port[0]), .D2(
    Data6_port[0]), .D3(Data7_port[0]), .S0(SelAux_0_0_net),
    .S1(SelAux_1_0_net), .Y(MX4_7_Y));
MX4 MX4_6(.D0(Data0_port[1]), .D1(Data1_port[1]), .D2(
    Data2_port[1]), .D3(Data3_port[1]), .S0(SelAux_0_0_net),
    .S1(SelAux_1_0_net), .Y(MX4_6_Y));
MX2 MX2_Result_7_inst(.A(MX4_9_Y), .B(MX4_15_Y), .S(
    SelAux_2_5_net), .Y(Result[7]));
BUFF BUFF_SelAux_0_12_inst(.A(Sel0), .Y(SelAux_0_12_net));
MX4 MX4_5(.D0(Data4_port[3]), .D1(Data5_port[3]), .D2(
    Data6_port[3]), .D3(Data7_port[3]), .S0(SelAux_0_6_net),
    .S1(SelAux_1_6_net), .Y(MX4_5_Y));
MX4 MX4_3(.D0(Data4_port[6]), .D1(Data5_port[6]), .D2(
    Data6_port[6]), .D3(Data7_port[6]), .S0(SelAux_0_12_net),
    .S1(SelAux_1_12_net), .Y(MX4_3_Y));
BUFF BUFF_SelAux_1_6_inst(.A(Sel1), .Y(SelAux_1_6_net));
MX4 MX4_2(.D0(Data4_port[1]), .D1(Data5_port[1]), .D2(
    Data6_port[1]), .D3(Data7_port[1]), .S0(SelAux_0_0_net),
    .S1(SelAux_1_0_net), .Y(MX4_2_Y));
MX4 MX4_0(.D0(Data0_port[5]), .D1(Data1_port[5]), .D2(
    Data2_port[5]), .D3(Data3_port[5]), .S0(SelAux_0_6_net),
    .S1(SelAux_1_6_net), .Y(MX4_0_Y));
MX2 MX2_Result_4_inst(.A(MX4_11_Y), .B(MX4_1_Y), .S(
    SelAux_2_0_net), .Y(Result[4]));

```

endmodule